# 8-bit Microcontroller

CMOS

# F<sup>2</sup>MC-8FX MB95150M Series

# MB95156M/F156M/F156N/F156J/FV100D-103

#### DESCRIPTION

The MB95150M series is general-purpose, single-chip microcontrollers. In addition to a compact instruction set, the microcontrollers contain a variety of peripheral functions.

Note : F<sup>2</sup>MC is the abbreviation of FUJITSU Flexible Microcontroller.

### ■ FEATURE

#### • F<sup>2</sup>MC-8FX CPU core

Instruction set optimized for controllers

- Multiplication and division instructions
- 16-bit arithmetic operations
- Bit test branch instruction
- Bit manipulation instructions etc.
- Clock
  - Main clock
  - Main PLL clock
  - Sub clock
  - Sub PLL clock

(Continued)

#### Be sure to refer to the "Check Sheet" for the latest cautions on development.

"Check Sheet" is seen at the following support page URL : http://www.fujitsu.com/global/services/microelectronics/product/micom/support/index.html

"Check Sheet" lists the minimal requirement items to be checked to prevent problems beforehand in system development.



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- Timer
  - 8/16-bit compound timer × 2 channels
     Can be used to interval timer, PWC timer, PWM timer and input capture.
  - 8/16-bit PPG  $\times$  2 channels
  - 16-bit PPG × 1 channel
  - Time-base timer  $\times$  1 channel
  - Watch prescaler  $\times$  1 channel
- LIN-UART × 1 channel
  - LIN function, clock asynchronous (UART) or clock synchronous (SIO) serial data transfer capable
  - Full duplex double buffer
- UART/SIO × 1 channel
  - Clock asynchronous (UART) or clock synchronous (SIO) serial data transfer capable
  - Full duplex double buffer
- External interrupt  $\times$  8 channels
  - Interrupt by edge detection (rising, falling, or both edges can be selected)
  - Can be used to recover from low-power consumption (standby) modes.
- $\bullet$  8/10-bit A/D converter  $\times$  8 channels
  - 8-bit or 10-bit resolution can be selected.
- LCD controller (LCDC)
  - 16 SEG × 4 COM (Max 64 pixels)
  - With blinking function
- Low-power consumption (standby) mode
  - Stop mode
  - Sleep mode
  - Watch mode
  - Time-base timer mode
- I/O port: Max 39
- General-purpose I/O ports (CMOS) : 39 ports
- Programmable input voltage levels of port
  - Automotive input level / CMOS input level / hysteresis input level
- Flash memory security function Protects the content of Flash memory (Flash memory device only)

### ■ PRODUCT LINEUP

Par	Part number ameter	MB95156M	MB95F156M	MB95F156N	MB95F156J				
Тур	pe	MASK ROM product		Flash memory produc	ot				
RO	M capacity		32	Kbytes					
RA	M capacity		1 Kbyte						
Res	set output	Yes/No	Yes/No Yes N						
<del>.</del>	Clock system	Dual clock							
Option*1	Low voltage detection reset	Yes/No	No	Y	Yes				
Ŭ	Clock supervisor	Yes/No		No	Yes				
CP	U functions	Number of basic instructions: 136Instruction bit length: 8 bitsInstruction length: 1 to 3 bytesData bit length: 1, 8, and 16 bitsMinimum instruction execution time: 61.5 ns (at machine clock frequency 16.25 MHInterrupt processing time: 0.6 µs (at machine clock frequency 16.25 MH							
	Ports (Max 39 ports)	General-purpose I/O Programmable input Automotive i	voltage levels of po		input level				
	Time-base timer (1 channel)	Interrupt cycle : 0.5 n	ns, 2.1 ms, 8.2 ms,	32.8 ms (at main oscilla	illation clock 4 MHz)				
	Watchdog timer	Reset generated cyc At main oscillation clo At sub oscillation clo	ock 10 MHz : Min						
	Wild register	Capable of replacing	3 bytes of ROM da	ta					
I functions	UART/SIO (1 channel)	Data transfer capable in UART/SIO Full duplex double buffer, variable data length (5/6/7/8-bit), built-in baud rate generator NRZ type transfer format, error detected function LSB-first or MSB-first can be selected. Clock asynchronous (UART) or clock synchronous (SIO) serial data transfer ca							
Dedicated reload timer allowing a wide range of communication speeds to beELIN-UARTImage: Communication speeds to beImage: Communic									
	8/10-bit A/D converter (8 channels)	8-bit or 10-bit resolution can be selected.							
COM output       : 4 (Max)         SEG output       : 16 (Max)         LCD controller       16 SEG × 4 COM       : 64 pixels can be displayed.         (LCDC)       Duty LCD mode       Operable in LCD standby mode         With blinking function       Built-in division resistance for LCD drive									

(Continued)

Par	Part number rameter	MB95156M MB95F156M MB95F156N MB95F156J									
	8/16-bit compound timer (2 channels)	× 1 channel". Built-in timer function waveform output	timer can be used as n, PWC function, PWI nal clocks and extern	M function, capture fu	inction, and square						
ictions	16-bit PPG (1 channel)	PWM mode or one-shot mode can be selected. Counter operating clock : Eight selectable clock sources Support for external trigger start									
Peripheral functions	8/16-bit PPG (2 channels)	Each channel of the PPG can be used as "8-bit PPG $\times$ 2 channels" or "16-bit PPG $\times$ 1 channel". Counter operating clock : Eight selectable clock sources									
Perip	Watch counter	Count clock : Four selectable clock sources (125 ms, 250 ms, 500 ms, or 1 s) Counter value can be set from 0 to 63. (Capable of counting for 1 minute when selecting clock source 1 second and setting counter value to 60)									
	Watch prescaler (1 channel)	4 selectable interval times (125 ms, 250 ms, 500 ms, or 1 s)									
	External interrupt (8 channels)		tection (rising, falling, ver from standby mod		e selected.)						
Flash memory       Supports automatic programming, Embedded Algorithm <sup>™ *2</sup> Write/Erase/Erase-Suspend/Resume commands         A flag indicating completion of the algorithm         Number of write/erase cycles (Minimum) : 10000 times         Data retention time : 20 years         Boot block configuration         Erase can be performed on each block         Block protection with external programming voltage         Flash Security Feature for protecting the content of the Flash											
Sta	ndby mode	Sleep, stop, watch, a									

\*1 : For details of option, refer to "
MASK OPTION".

\*2 : Embedded Algorithm is a trade mark of Advanced Micro Devices Inc.

Note : Part number of evaluation products in MB95150M series is MB95FV100D-103. When using it, the MCU board (MB2146-303A) is required.

#### ■ OSCILLATION STABILIZATION WAIT TIME

The initial value of the main clock oscillation stabilization wait time is fixed to the maximum value. The maximum value is shown as follows.

Oscillation stabilization wait time	Remarks
(214–2) /Бсн	Approx. 4.10 ms (at main oscillation clock 4 MHz)

### ■ PACKAGES AND CORRESPONDING PRODUCTS

Part number Package	MB95156M	MB95F156M/F156N/F156J	MB95FV100D-103
FPT-48P-M26	0	0	×
FPT-52P-M01	0	0	X
BGA-224P-M08	×	×	0

 $\bigcirc$ : Available

 $\times\,$  : Unavailable

#### DIFFERENCES AMONG PRODUCTS AND NOTES ON SELECTING PRODUCTS

#### Notes on Using Evaluation Products

The Evaluation product has not only the functions of the MB95150M series but also those of other products to support software development for multiple series and models of the F<sup>2</sup>MC-8FX family. The I/O addresses for peripheral resources not used by the MB95150M series are therefore access-barred. Read/write access to these access-barred addresses may cause peripheral resources supposed to be unused to operate, resulting in unexpected malfunctions of hardware or software.

Particularly, do not use word access to odd numbered byte address in the prohibited areas (If these access are used, the address may be read or written unexpectedly).

Also, as the read values of prohibited addresses on the evaluation product are different to the values on the Flash memory and MASK ROM products, do not use these values in the program.

The functions corresponding to certain bits in single-byte registers may not be supported on some mask ROM and Flash memory products. However, reading or writing to these bits will not cause malfunction of the hardware. Also, as the evaluation, Flash memory, and mask ROM products are designed to have identical software operation, no particular precautions are required.

Difference of Memory Spaces

If the amount of memory on the Evaluation product is different from that of the Flash memory product or MASK ROM product, carefully check the difference in the amount of memory from the model to be actually used when developing software.

For details of memory space, refer to "■ CPU CORE".

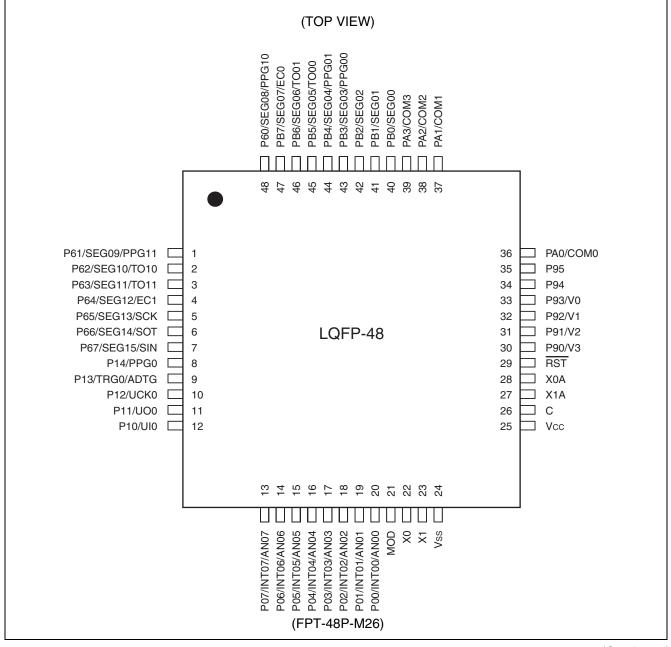
- Current Consumption
  - The current consumption of Flash memory product is typically greater than for MASK ROM product.
  - For details of current consumption, refer to "■ ELECTRICAL CHARACTERISTICS".
- Package

For details of information on each package, refer to "■ PACKAGES AND CORRESPONDING PRODUCTS" and "■ PACKAGE DIMENSIONS".

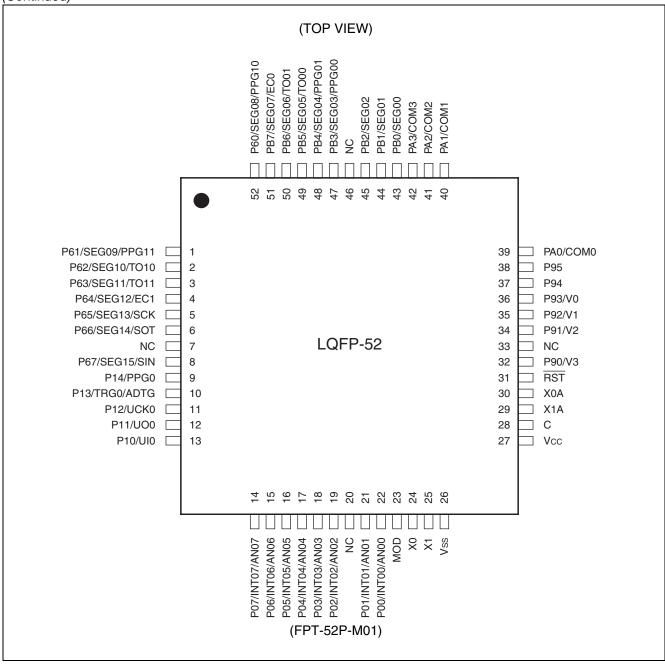
Operating voltage

The operating voltage are different between the Evaluation, Flash memory products, and MASK ROM product. For details of operating voltage, refer to "■ ELECTRICAL CHARACTERISTICS".

#### PIN ASSIGNMENT







### ■ PIN DESCRIPTION

Pin no.			I/O	Function			
LQFP*1	LQFP*2	Pin name	circuit type* <sup>3</sup>	Function			
1	1	P61/SEG09/ PPG11		General-purpose I/O port. The pin is shared with LCDC SEG output (SEG09) and 8/16-bit PPG ch.1 output (PPG11).			
2	2	P62/SEG10/TO10		General-purpose I/O port.			
3	3	P63/SEG11/TO11		The pins are shared with LCDC SEG output (SEG10, SEG11) and 8/16-bit compound timer ch.1 output (TO10, TO11).			
4	4	P64/SEG12/EC1	М	General-purpose I/O port. The pin is shared with LCDC SEG output (SEG12) and 8/16-bit compound timer ch.1 clock input (EC1).			
5	5	P65/SEG13/SCK		General-purpose I/O port. The pin is shared with LCDC SEG output (SEG13) and LIN- UART clock I/O (SCK) .			
6	6	P66/SEG14/SOT		General-purpose I/O port. The pin is shared with LCDC SEG output (SEG14) and LIN- UART data output (SOT) .			
7	8	P67/SEG15/SIN	N	General-purpose I/O port. The pin is shared with LCDC SEG output (SEG15) and LIN- UART data input (SIN) .			
8	9	P14/PPG0		General-purpose I/O port. The pin is shared with 16-bit PPG ch.0 output (PPG0) .			
9	10	P13/TRG0/ADTG	H	General-purpose I/O port. The pin is shared with 16-bit PPG ch.0 trigger input (TRG0) and A/D converter trigger input (ADTG) .			
10	11	P12/UCK0		General-purpose I/O port. The pin is shared with UART/SIO ch.0 clock I/O (UCK0) .			
11	12	P11/UO0		General-purpose I/O port. The pin is shared with UART/SIO ch.0 data output (UO0) .			
12	13	P10/UI0	G	General-purpose I/O port. The pin is shared with UART/SIO ch.0 data input (UI0) .			
13	14	P07/INT07/AN07					
14	15	P06/INT06/AN06					
15	16	P05/INT05/AN05					
16	17	P04/INT04/AN04	D	General-purpose I/O port. The pins are shared with external interrupt input (INT00 to INT07)			
17	18	P03/INT03/AN03		and A/D converter analog input (AN00 to AN07).			
18	19	P02/INT02/AN02					
19	21	P01/INT01/AN01					
20	22	P00/INT00/AN00					
21	23	MOD	В	The operating mode designation pin			

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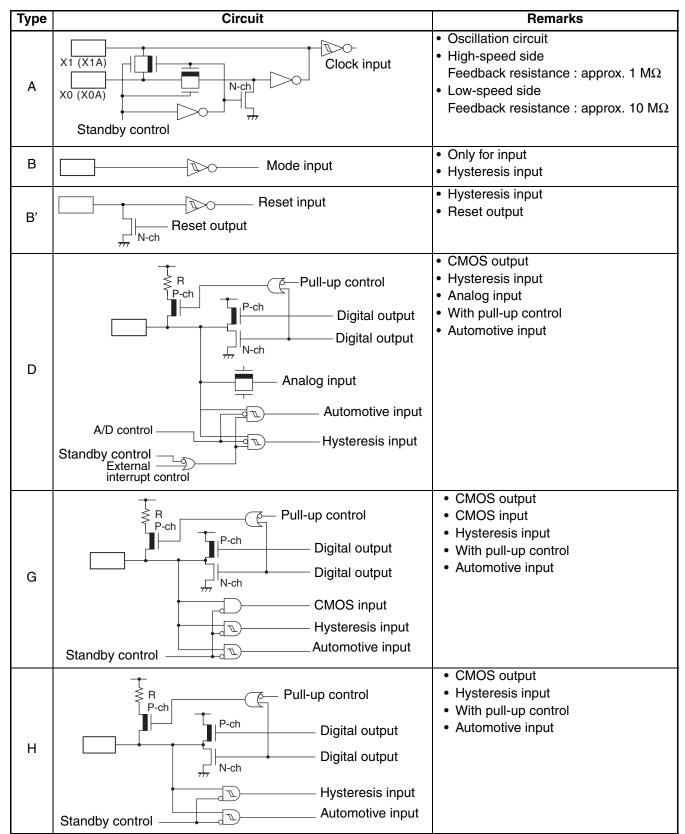
Pin no.		<b>D</b> .	.I/O	<b>F</b> or all an				
LQFP*1	LQFP*2	Pin name	circuit type* <sup>3</sup>	Function				
22	24	X0	A	Main clock oscillation pins				
23	25	X1	~					
24	26	Vss		Power supply pin (GND)				
25	27	Vcc		Power supply pin				
26	28	С		Capacitor connection pin				
27	29	X1A	A	Sub clock oscillation pins (32 kHz)				
28	30	X0A	~					
29	31	RST	B'	Reset pin				
30	32	P90/V3						
31	34	P91/V2	R	General-purpose I/O port. The pins are shared with power supply pin for LCDC drive (V0 to				
32	35	P92/V1		V3).				
33	36	P93/V0						
34	37	P94	s	General-purpose I/O port				
35	38	P95	3	General-pulpose i/O port				
36	39	PA0/COM0						
37	40	PA1/COM1	М	General-purpose I/O port.				
38	41	PA2/COM2	IVI	The pins are shared with LCDC COM output (COM0 to COM3) .				
39	42	PA3/COM3						
40	43	PB0/SEG00						
41	44	PB1/SEG01		General-purpose I/O port. The pins are shared with LCDC SEG output (SEG00 to SEG02) .				
42	45	PB2/SEG02						
43	47	PB3/SEG03/ PPG00		General-purpose I/O port.				
44	48	PB4/SEG04/ PPG01	М	The pins are shared with LCDC SEG output (SEG03, SEG04) and 8/16-bit PPG ch.0 output (PPG00, PPG01).				
45	49	PB5/SEG05/TO00	1	General-purpose I/O port.				
46	50	PB6/SEG06/TO01		The pins are shared with LCDC SEG output (SEG05, SEG06) and 8/16-bit compound timer ch.0 output (TO00, TO01).				
47	51	PB7/SEG07/EC0		General-purpose I/O port. The pin is shared with LCDC SEG output (SEG07) and 8/16-bit compound timer ch.0 clock input (EC0).				
48	52	P60/SEG08/ PPG10	М	General-purpose I/O port. The pin is shared with LCDC SEG output (SEG08) and 8/16-bit PPG ch.1 output (PPG10) .				
_	7, 20, 33, 46	NC	_	Internal connect pins. Be sure this pin is left open.				

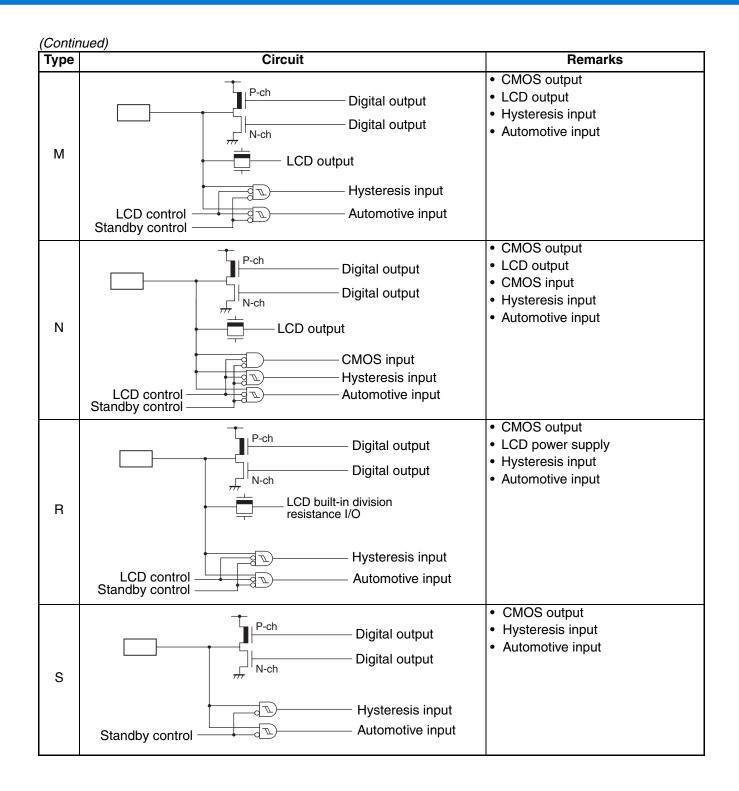
\*1 : FPT-48P-M26

\*2 : FPT-52P-M01

\*3 : For the I/O circuit type, refer to "■ I/O CIRCUIT TYPE".

■ I/O CIRCUIT TYPE





#### HANDLING DEVICES

Preventing Latch-up

Care must be taken to ensure that maximum voltage ratings are not exceeded when they are used.

Latch-up may occur on CMOS ICs if voltage higher than  $V_{CC}$  or lower than  $V_{SS}$  is applied to input and output pins other than medium- and high-withstand voltage pins or if higher than the rating voltage is applied between  $V_{CC}$  pin and  $V_{SS}$  pin.

When latch-up occurs, power supply current increases rapidly and might thermally damage elements.

• Stable Supply Voltage

Supply voltage should be stabilized.

A sudden change in power-supply voltage may cause a malfunction even within the guaranteed operating range of the Vcc power-supply voltage.

For stabilization, in principle, keep the variation in Vcc ripple (p-p value) in a commercial frequency range (50/60 Hz) not to exceed 10% of the standard Vcc value and suppress the voltage variation so that the transient variation rate does not exceed 0.1 V/ms during a momentary change such as when the power supply is switched.

• Precautions for Use of External Clock

Even when an external clock is used, oscillation stabilization wait time is required for power-on reset, wake-up from sub clock mode or stop mode.

### PIN CONNECTION

• Treatment of Unused Pin

Leaving unused input pins unconnected can cause abnormal operation or latch-up, leaving to permanent damage. Unused input pins should always be pulled up or down through resistance of at least 2 k $\Omega$ . Any unused input/output pins may be set to output mode and left open, or set to input mode and treated the same as unused input pins. If there is unused output pin, make it to open.

• Power Supply Pins

In products with multiple V<sub>cc</sub> or V<sub>ss</sub> pins, the pins of the same potential are internally connected in the device to avoid abnormal operations including latch-up. However, you must connect the pins to external power supply and a ground line to lower the electro-magnetic emission level, to prevent abnormal operation of strobe signals caused by the rise in the ground level, and to conform to the total output current rating.

Moreover, connect the current supply source with the Vcc and Vss pins of this device at the low impedance.

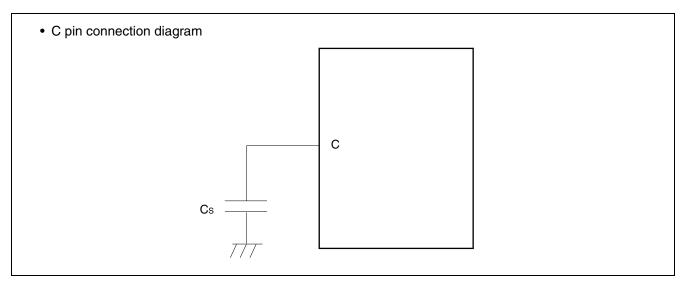
It is also advisable to connect a ceramic bypass capacitor of approximately 0.1  $\mu F$  between Vcc and Vss pins near this device.

• Mode Pin (MOD)

Connect the MOD pin directly to Vcc or Vss.

To prevent the device unintentionally entering test mode due to noise, lay out the printed circuit board so as to minimize the distance from the MOD pin to Vcc or Vss pins and to provide a low-impedance connection.

Use a ceramic capacitor or a capacitor with equivalent frequency characteristics. A bypass capacitor of  $V_{CC}$  pin must have a capacitance value higher than Cs. For connection of smoothing capacitor Cs, refer to the diagram below.



• NC Pins

Any pins marked "NC" (not connected) must be left open.

#### PROGRAMMING FLASH MEMORY MICROCONTROLLERS USING PARALLEL PROGRAMMER

#### • Supported Parallel Programmers and Adapters

The following table lists supported parallel programmers and adapters.

Package	Applicable adapter model	Parallel programmers
FPT-48P-M26	TEF110-95F156HPFV	AF9708 (Ver 02.35G or more)
FPT-52P-M01	TEF110-95F156HPMC	AF9709/B (Ver 02.35G or more) AF9723+AF9834 (Ver 02.08E or more)

Note : For information on applicable adapter models and parallel programmers, contact the following: Flash Support Group, Inc. TEL: +81-53-428-8380

#### • Sector Configuration

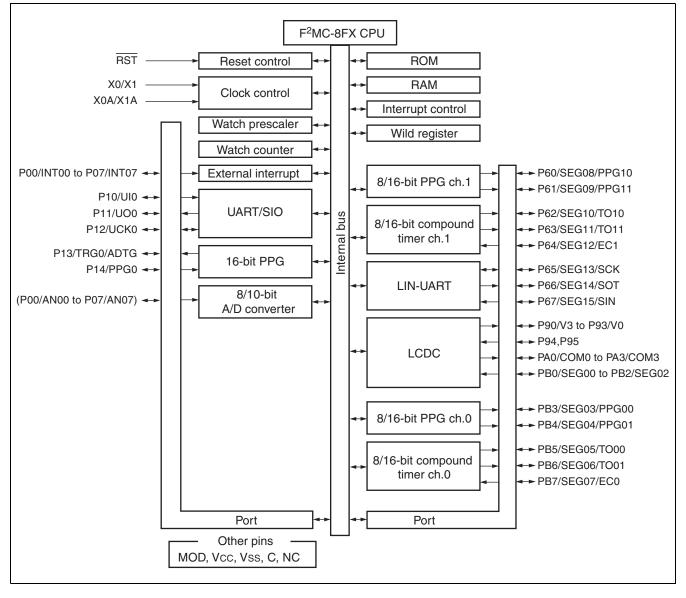
The individual sectors of Flash memory correspond to addresses used for CPU access and programming by the parallel programmer as follows:

Flash memory	CPU address	Programmer address*
32 Kbytes	8000н	18000 <sub>H</sub>
0_1.00	<b>FFFF</b> <sub>H</sub>	1FFFF <sub>H</sub>

#### • Programming Method

- 1) Set the type code of the parallel programmer to 17222.
- 2) Load program data to programmer addresses 18000H to 1FFFFH.
- 3) Programmed by parallel programmer.

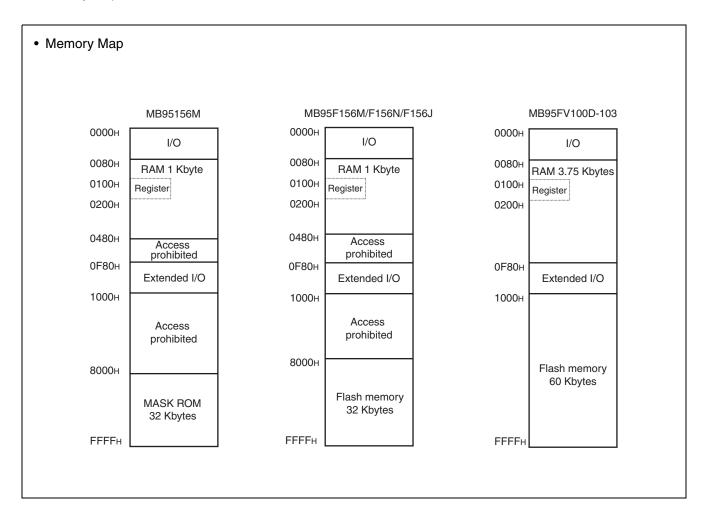
#### BLOCK DIAGRAM



### CPU CORE

#### 1. Memory space

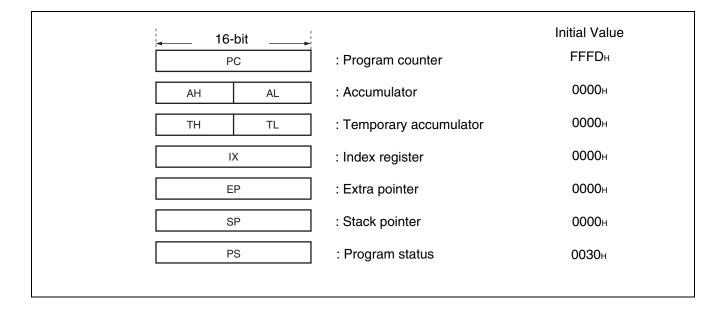
Memory space of the MB95150M series is 64 Kbytes and consists of I/O area, data area, and program area. The memory space includes special-purpose areas such as the general-purpose registers and vector table. Memory map of the MB95150M series is shown below.



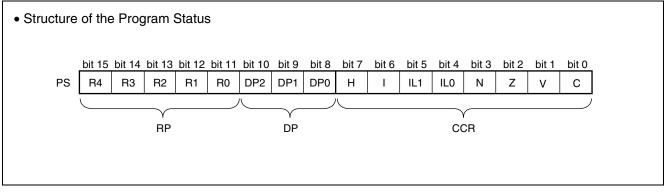
#### 2. Register

The MB95150M series has two types of registers; dedicated registers in the CPU and general-purpose registers in the memory. The dedicated registers are as follows:

Program counter (PC)	: A 16-bit register to indicate locations where instructions are stored.
Accumulator (A)	: A 16-bit register for temporary storage of arithmetic operations. In the case of an 8-bit data processing instruction, the lower 1 byte is used.
Temporary accumulator (T)	: A 16-bit register which performs arithmetic operations with the accumulator. In the case of an 8-bit data processing instruction, the lower 1 byte is used.
Index register (IX)	: A 16-bit register for index modification.
Extra pointer (EP)	: A 16-bit pointer to point to a memory address.
Stack pointer (SP)	: A 16-bit register to indicate a stack area.
Program status (PS)	: A 16-bit register for storing a register bank pointer, a direct bank pointer, and a condition code register.



The PS can further be divided into higher 8 bits for use as a register bank pointer (RP) and a direct bank pointer (DP) and the lower 8 bits for use as a condition code register (CCR). (Refer to the diagram below.)



The RP indicates the address of the register bank currently being used. The relationship between the content of RP and the real address conforms to the conversion rule illustrated below:

Rule for Conversion of Actual Addresses in the General-purpose Register Area																
										RP	upp	er		OP c	ode l	ower
	"0"	"0"	"0"	"0"	"0"	"0"	"0"	"1"	R4	R3	R2	R1	R0	b2	b1	b0
	¥	¥	¥	¥	¥	¥	¥	¥	¥	¥	¥	¥	¥	¥	¥	+
Generated address	A15	A14	A13	A12	A11	A10	A9	A8	A7	A6	A5	A4	A3	A2	A1	A0

The DP specifies the area for mapping instructions (16 different instructions such as MOV A, dir) using direct addresses to 0080<sup> H</sup> to 00FF<sup> H</sup>.

Direct bank pointer (DP2 to DP0)	Specified address area	Mapping area
XXX <sub>B</sub> (no effect to mapping)	0000н to 007Fн	0000н to 007Fн (without mapping)
000 <sup>B</sup> (initial value)		0080н to 00FFн (without mapping)
001в		0100н to 017Fн
010 <sub>B</sub>		0180н to 01FFн
011в	0080н to 00FFн	0200н to 027Fн
100в		0280н to 02FFн
101в		0300н to 037Fн
110 <sub>B</sub>		0380н to 03FFн
111в	]	0400н to 047Fн

The CCR consists of the bits indicating arithmetic operation results or transfer data contents and the bits that control CPU operations at interrupt.

- H flag : Set to "1" when a carry or a borrow from bit 3 to bit 4 occurs as a result of an arithmetic operation. Cleared to "0" otherwise. This flag is for decimal adjustment instructions.
- I flag : Interrupt is enabled when this flag is set to "1". Interrupt is disabled when this flag is set to "0". The flag is set to "0" when reset.
- IL1, IL0 : Indicates the level of the interrupt currently enabled. Processes an interrupt only if its request level is higher than the value indicated by these bits.

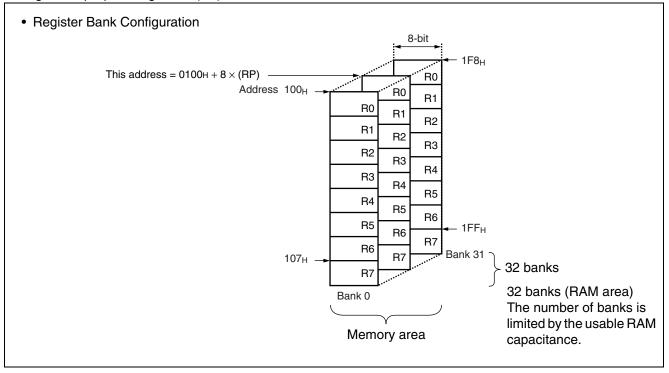
IL1	IL0	Interrupt level	Priority
0	0	0	High
0	1	1	<b>≜</b>
1	0	2	
1	1	3	Low (no interruption)

- N flag : Set to "1" if the MSB is set to "1" as the result of an arithmetic operation. Cleared to "0" when the bit is set to "0".
- Z flag : Set to "1" when an arithmetic operation results in "0". Cleared to "0" otherwise.
- V flag : Set to "1" if the complement on 2 overflows as a result of an arithmetic operation. Cleared to "0" otherwise.
- C flag : Set to "1" when a carry or a borrow from bit 7 occurs as a result of an arithmetic operation. Cleared to "0" otherwise. Set to the shift-out value in the case of a shift instruction.

The following general-purpose registers are provided:

General-purpose registers: 8-bit data storage registers

The general-purpose registers are 8 bits and located in the register banks on the memory. 1-bank contains 8-register. Up to a total of 32 banks can be used on the MB95150M series. The bank currently in use is specified by the register bank pointer (RP), and the lower 3 bits of OP code indicates the general-purpose register 0 (R0) to general-purpose register 7 (R7).



### ■ I/O MAP

Address	Register abbreviation	Register name	R/W	Initial value
0000н	PDR0	Port 0 data register	R/W	0000000в
<b>0001</b> н	DDR0	Port 0 direction register		0000000в
0002н	PDR1	Port 1 data register	R/W	0000000в
0003н	DDR1	Port 1 direction register	R/W	0000000в
0004н		(Disabled)		
0005н	WATR	Oscillation stabilization wait time setting register	R/W	11111111в
0006н	PLLC	PLL control register	R/W	0000000в
0007н	SYCC	System clock control register	R/W	1010X011в
<b>0008</b> н	STBC	Standby control register	R/W	0000000в
<b>0009</b> н	RSRR	Reset source register	R/W	XXXXXXXXB
<b>000А</b> н	TBTC	Time-base timer control register	R/W	0000000в
<b>000В</b> н	WPCR	Watch prescaler control register	R/W	0000000в
<b>000С</b> н	WDTC	Watchdog timer control register	R/W	0000000в
000Dн to 0015н		(Disabled)		
<b>0016</b> н	PDR6	Port 6 data register	R/W	0000000в
<b>0017</b> н	DDR6	Port 6 direction register	R/W	0000000в
0018н to 001Вн	_	(Disabled)	_	_
001Cн	PDR9	Port 9 data register	R/W	0000000в
001Dн	DDR9	Port 9 direction register	R/W	0000000в
<b>001Е</b> н	PDRA	Port A data register	R/W	0000000в
<b>001F</b> н	DDRA	Port A direction register	R/W	0000000в
0020н	PDRB	Port B data register	R/W	0000000в
<b>0021</b> н	DDRB	Port B direction register	R/W	0000000в
0022н to 002Вн	_	(Disabled)		
002Cн	PUL0	Port 0 pull-up register		0000000в
002Dн	PUL1	Port 1 pull-up register		0000000в
002Ен to 0035н		(Disabled)		_

Address	Register abbreviation	Register name	R/W	Initial value
0036н	T01CR1	8/16-bit compound timer 01 control status register 1 ch.0	R/W	0000000в
0037н	T00CR1	8/16-bit compound timer 00 control status register 1 ch.0	R/W	0000000в
0038н	T11CR1	8/16-bit compound timer 11 control status register 1 ch.1	R/W	0000000в
0039н	T10CR1	8/16-bit compound timer 10 control status register 1 ch.1	R/W	0000000в
003Ан	PC01	8/16-bit PPG1 control register ch.0	R/W	0000000в
003Вн	PC00	8/16-bit PPG0 control register ch.0	R/W	0000000в
003Сн	PC11	8/16-bit PPG1 control register ch.1	R/W	0000000в
003Dн	PC10	8/16-bit PPG0 control register ch.1	R/W	0000000в
003Eн to 0041н		(Disabled)		_
0042н	PCNTH0	16-bit PPG status control register (upper byte) ch.0	R/W	0000000в
0043н	PCNTL0	16-bit PPG status control register (lower byte) ch.0	R/W	0000000в
0044н to 0047н		(Disabled)		
0048н	EIC00	External interrupt circuit control register ch.0/ch.1	R/W	0000000в
0049н	EIC10	External interrupt circuit control register ch.2/ch.3	R/W	0000000в
004Aн	EIC20	External interrupt circuit control register ch.4/ch.5	R/W	0000000в
004Bн	EIC30	External interrupt circuit control register ch.6/ch.7	R/W	0000000в
004Сн to 004Fн		(Disabled)	_	
0050н	SCR	LIN-UART serial control register	R/W	0000000в
<b>0051</b> н	SMR	LIN-UART serial mode register	R/W	0000000в
0052н	SSR	LIN-UART serial status register	R/W	00001000в
0053н	RDR/TDR	LIN-UART reception/transmission data register	R/W	0000000в
0054н	ESCR	LIN-UART extended status control register	R/W	00000100в
0055н	ECCR	LIN-UART extended communication control register	R/W	00000XXB
0056н	SMC10	UART/SIO serial mode control register 1 ch.0	R/W	0000000в
0057н	SMC20	UART/SIO serial mode control register 2 ch.0	R/W	0010000в
0058н	SSR0	UART/SIO serial status register ch.0	R/W	0000001в
<b>0059</b> н	TDR0	UART/SIO serial output data register ch.0		0000000в
<b>005А</b> н	RDR0	UART/SIO serial input data register ch.0	R	0000000в
005Вн to 006Вн		(Disabled)		

	Register abbreviation	Register name	R/W	Initial value
006Cн	ADC1	8/10-bit A/D converter control register 1	R/W	0000000в
006Dн	ADC2	8/10-bit A/D converter control register 2	R/W	0000000в
006Eн	ADDH	8/10-bit A/D converter data register (Upper byte)	R/W	0000000в
<b>006F</b> н	ADDL	8/10-bit A/D converter data register (Lower byte)	R/W	0000000в
0070н	WCSR	Watch counter status register	R/W	0000000в
<b>0071</b> н		(Disabled)		
0072н	FSR	Flash memory status register	R/W	000X0000B
0073н	SWRE0	Flash memory sector writing control register 0	R/W	0000000в
0074н	SWRE1	Flash memory sector writing control register 1	R/W	0000000в
0075н		(Disabled)		
0076н	WREN	Wild register address compare enable register	R/W	0000000в
0077н	WROR	Wild register data test setting register	R/W	0000000в
<b>0078</b> н		Register bank pointer (RP), Mirror of direct bank pointer (P)		
<b>0079</b> н	ILR0	Interrupt level setting register 0	R/W	11111111в
<b>007А</b> н	ILR1	Interrupt level setting register 1		11111111B
<b>007В</b> н	ILR2	Interrupt level setting register 2	R/W	11111111 <sub>В</sub>
<b>007С</b> н	ILR3	Interrupt level setting register 3	R/W	11111111в
007Dн	ILR4	Interrupt level setting register 4	R/W	11111111 <sub>В</sub>
<b>007E</b> н	ILR5	Interrupt level setting register 5	R/W	11111111в
007Fн		(Disabled)		
0F80н	WRARH0	Wild register address setting register (upper byte) ch.0	R/W	0000000в
0F81н	WRARL0	Wild register address setting register (lower byte) ch.0	R/W	0000000в
0F82н	WRDR0	Wild register data setting register ch.0	R/W	0000000в
0F83⊦	WRARH1	Wild register address setting register (upper byte) ch.1	R/W	0000000в
0F84⊦	WRARL1	Wild register address setting register (lower byte) ch.1	R/W	0000000в
0F85⊦	WRDR1	Wild register data setting register ch.1	R/W	0000000в
0F86н	WRARH2	Wild register address setting register (upper byte) ch.2	R/W	0000000в
0F87н	WRARL2	Wild register address setting register (lower byte) ch.2	R/W	0000000в
0F88⊦	WRDR2	Wild register data setting register ch.2	R/W	0000000в
0F89н to 0F91н	_	(Disabled)		_
0F92н	T01CR0	8/16-bit compound timer 01 control status register 0 ch.0	R/W	0000000в
0F93⊦	T00CR0	8/16-bit compound timer 00 control status register 0 ch.0	R/W	0000000в
0F94н	T01DR	8/16-bit compound timer 01 data register ch.0	R/W	0000000в

Address	Register abbreviation	Register name	R/W	Initial value
0F95н	T00DR	8/16-bit compound timer 00 data register ch.0	R/W	0000000в
0 <b>F</b> 96н	TMCR0	8/16-bit compound timer 00/01 timer mode control register ch.0	R/W	0000000в
0 <b>F</b> 97н	T11CR0	8/16-bit compound timer 11 control status register 0 ch.1	R/W	0000000в
0 <b>F</b> 98н	T10CR0	8/16-bit compound timer 10 control status register 0 ch.1	R/W	0000000в
0F99н	T11DR	8/16-bit compound timer 11 data register ch.1	R/W	0000000в
0F9A⊦	T10DR	8/16-bit compound timer 10 data register ch.1	R/W	0000000в
0F9BH	TMCR1	8/16-bit compound timer 10/11 timer mode control register ch.1	R/W	0000000в
0F9CH	PPS01	8/16-bit PPG1 cycle setting buffer register ch.0	R/W	11111111в
0F9DH	PPS00	8/16-bit PPG0 cycle setting buffer register ch.0	R/W	11111111в
0F9EH	PDS01	8/16-bit PPG1 duty setting buffer register ch.0	R/W	11111111в
0F9Fн	PDS00	8/16-bit PPG0 duty setting buffer register ch.0	R/W	11111111в
0FA0н	PPS11	8/16-bit PPG1 cycle setting buffer register ch.1	R/W	11111111в
0FA1н	PPS10	8/16-bit PPG0 cycle setting buffer register ch.1	R/W	11111111в
0FA2H	PDS11	8/16-bit PPG1 duty setting buffer register ch.1	R/W	11111111в
0FA3н	PDS10	8/16-bit PPG0 duty setting buffer register ch.1	R/W	11111111в
0FA4н	PPGS	8/16-bit PPG start register		0000000в
0FA5н	REVC	8/16-bit PPG output inversion register		0000000в
0FA6н to 0FA9н		(Disabled)		_
0FAAH	PDCRH0	16-bit PPG down counter register (upper byte) ch.0	R	0000000в
0FABH	PDCRL0	16-bit PPG down counter register (lower byte) ch.0	R	0000000в
0FACH	PCSRH0	16-bit PPG cycle setting buffer register (upper byte) ch.0	R/W	11111111в
0FADH	PCSRL0	16-bit PPG cycle setting buffer register (lower byte) ch.0	R/W	11111111в
0FAEH	PDUTH0	16-bit PPG duty setting buffer register (upper byte) ch.0	R/W	11111111в
0FAFн	PDUTL0	16-bit PPG duty setting buffer register (lower byte) ch.0	R/W	11111111в
0FB0н to 0FBBн		(Disabled)		
0FBCH	BGR1	LIN-UART baud rate generator register 1	R/W	0000000в
0FBDH	BGR0	LIN-UART baud rate generator register 0	R/W	0000000в
0FBEH	PSSR0	UART/SIO dedicated baud rate generator prescaler selection register ch.0		0000000в
0FBFн	BRSR0	UART/SIO dedicated baud rate generator baud rate setting register ch.0	R/W	0000000в
0FC0н to 0FC2н		(Disabled)		_

Address	Register abbreviation	Register name	R/W	Initial value
0FC3н	AIDRL	A/D input disable register (lower byte)	R/W	0000000в
0FC4н	LCDCC	LCDC control register	R/W	00010000в
0FC5н	LCDCE1	LCDC enable register 1	R/W	00110000в
0FC6н	LCDCE2	LCDC enable register 2	R/W	0000000в
0FC7н	LCDCE3	LCDC enable register 3	R/W	0000000в
0FC8н to 0FCAн		(Disabled)		_
0FCBH	LCDCB1	LCDC blinking setting register 1	R/W	0000000в
0FCCH	LCDCB2	LCDC blinking setting register 2	R/W	0000000в
0FCDн to 0FD4н	LCDRAM	LCDC display RAM	R/W	0000000в
0FD5н to 0FE2н	_	(Disabled)		
0FE3н	WCDR	Watch counter data register	R/W	00111111в
0FE4н to 0FE6н		(Disabled)		
0FE7н	ILSR2	Input level select register 2	R/W	0000000в
0FE8н, 0FE9н	_	(Disabled)	_	_
0FEAн	CSVCR	Clock supervisor control register	R/W	00011100в
0FEB⊦ to 0FED⊦		(Disabled)	_	
0FEEH	ILSR	Input level select register	R/W	0000000в
0FEFH	WICR	Interrupt pin control register	R/W	0100000в
0FF0н to 0FFFн		(Disabled)		

• R/W access symbols

R/W : Readable/Writable

- R : Read only
- W : Write only

• Initial value symbols

- 0 : The initial value of this bit is "0".
- 1 : The initial value of this bit is "1".
- X : The initial value of this bit is undefined.

### ■ INTERRUPT SOURCE TABLE

	Interrupt	Vector tab	le address	Bit name of	Same level		
Interrupt source	request number	Upper	Lower	interrupt level setting register	priority order (atsimultaneous occurrence)		
External interrupt ch.0	IRQ0	FFFA <sub>H</sub>	FFFB <sub>H</sub>	L00 [1 : 0]	High		
External interrupt ch.4	Inco		TTDH				
External interrupt ch.1	IRQ1	FFF8⊦	FFF9⊦	L01 [1 : 0]			
External interrupt ch.5	INUT	ГГГОН	FFF <b>9</b> H				
External interrupt ch.2	IRQ2	FFF6⊦	FFF7н	L02 [1 : 0]			
External interrupt ch.6	INQZ	ГГГОН	ГГГ/Н	LU2 [1.0]			
External interrupt ch.3	IRQ3	FFF4 <sub>H</sub>	FFF5H	1 02 [1 · 0]			
External interrupt ch.7	INQS	ГГГ4Н	ГГГЭН	L03 [1 : 0]			
UART/SIO ch.0	IRQ4	FFF2H	FFF3H	L04 [1 : 0]			
8/16-bit compound timer ch.0 (Lower)	IRQ5	FFF0H	FFF1н	L05 [1 : 0]			
8/16-bit compound timer ch.0 (Upper)	IRQ6	FFEEH	FFEFH	L06 [1 : 0]			
LIN-UART (reception)	IRQ7	FFECH	FFEDH	L07 [1 : 0]			
LIN-UART (transmission)	IRQ8	FFEAH	FFEBH	L08 [1 : 0]			
8/16-bit PPG ch.1 (Lower)	IRQ9	FFE8H	FFE9н	L09 [1 : 0]			
8/16-bit PPG ch.1 (Upper)	IRQ10	FFE6H	FFE7H	L10 [1 : 0]			
(Unused)	IRQ11	FFE4H	FFE5H	L11 [1 : 0]			
8/16-bit PPG ch.0 (Upper)	IRQ12	FFE2H	FFE3H	L12 [1 : 0]			
8/16-bit PPG ch.0 (Lower)	IRQ13	FFE0H	FFE1н	L13 [1 : 0]			
8/16-bit compound timer ch.1 (Upper)	IRQ14	FFDEH	FFDFH	L14 [1 : 0]			
16-bit PPG ch.0	IRQ15	FFDC <sub>H</sub>	FFDDH	L15 [1 : 0]			
(Unused)	IRQ16	<b>FFDA</b> H	<b>FFDB</b> H	L16 [1 : 0]			
(Unused)	IRQ17	FFD8H	FFD9н	L17 [1 : 0]			
8/10-bit A/D converter	IRQ18	FFD6н	FFD7н	L18 [1 : 0]			
Time-base timer	IRQ19	FFD4H	FFD5н	L19 [1 : 0]			
Watch prescaler/Watch counter	IRQ20	FFD2H	FFD3H	L20 [1 : 0]			
(Unused)	IRQ21	FFD0н	FFD1н	L21 [1 : 0]	_		
8/16-bit compound timer ch.1 (Lower)	IRQ22	FFCEH	FFCFH	L22 [1 : 0]	▼		
Flash memory	IRQ23	FFCC <sub>H</sub>	<b>FFCD</b> H	L23 [1 : 0]	Low		

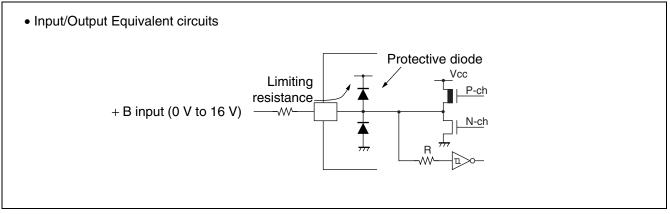
### ■ ELECTRICAL CHARACTERISTICS

### 1. Absolute Maximum Ratings

Devenueter	Cumhal	Rating		الما ا	Damarka		
Parameter	Symbol	Min	Max	Unit	Remarks		
Power supply voltage*1	Vcc	Vss - 0.3	Vss + 6.0	V			
Power supply voltage for LCD	V0 to V3	Vss - 0.3	Vss + 6.0	v	*2		
Input voltage*1	Vı	Vss - 0.3	Vss + 6.0	V	*3		
Output voltage*1	Vo	Vss - 0.3	Vss + 6.0	V	*3		
Maximum clamp current		- 2.0	+ 2.0	mA	Applicable to pins*4		
Total maximum clamp current	$\Sigma$   clamp		20	mA	Applicable to pins*4		
"L" level maximum output current	lol		15	mA	Applicable to pins*4		
"L" level average current	Iolav		4	mA	Applicable to pins <sup>*4</sup> Average output current = operating current × operating ratio (1 pin)		
"L" level total maximum output current	ΣΙοι	_	100	mA			
"L" level total average output current	ΣΙοιαν		50	mA	Total average output current = operating current × operating ratio (Total of pins)		
"H" level maximum output current	Іон		- 15	mA	Applicable to pins*4		
"H" level average current	Іонач		- 4	mA	Applicable to pins <sup>*4</sup> Average output current = operating current × operating ratio (1 pin)		
"H" level total maximum output current	ΣІон		- 100	mA			
"H" level total average output current	ΣΙοήαν	_	- 50	mA	Total average output current = operating current × operating ratio (Total of pins)		
Power consumption	Pd	—	320	mW			
Operating temperature	TA	- 40	+ 85	°C			
Storage temperature	Tstg	- 55	+ 150	°C			

#### (Continued)

- \*1 : The parameter is based on  $V_{SS} = 0.0 V$ .
- \*2 : V0 to V3 should not exceed Vcc + 0.3 V.
- \*3 : VI and Vo should not exceed Vcc + 0.3 V. VI must not exceed the rating voltage. However, if the maximum current to/from an input is limited by some means with external components, the IcLAMP rating supersedes the VI rating.
- \*4 : Applicable to pins : P00 to P07, P10 to P14, P60 to P67, P90 to P95, PA0 to PA3, PB0 to PB7
  - Use within recommended operating conditions.
  - Use at DC voltage (current).
  - +B signal is an input signal that exceeds Vcc voltage. The +B signal should always be applied a limiting resistance placed between the +B signal and the microcontroller.
  - The value of the limiting resistance should be set so that when the + B signal is applied the input current to the microcontroller pin does not exceed rated values, either instantaneously or for prolonged periods.
  - Note that when the microcontroller drive current is low, such as in the power saving modes, the +B input
    potential may pass through the protective diode and increase the potential at the Vcc pin, and this affects
    other devices.
  - Note that if the + B signal is inputted when the microcontroller power supply is off (not fixed at 0 V), the power supply is provided from the pins, so that incomplete operation may result.
  - Note that if the + B input is applied during power-on, the power supply is provided from the pins and the resulting power supply voltage may not be sufficient to operate the power-on reset.
  - Care must be taken not to leave the + B input pin open.
  - Note that analog system input/output pins other than the A/D input pins (LCD drive pins, etc.) cannot accept + B signal input.
  - Sample recommended circuits :



WARNING: Semiconductor devices can be permanently damaged by application of stress (voltage, current, temperature, etc.) in excess of absolute maximum ratings. Do not exceed these ratings.

#### 2. Recommended Operating Conditions

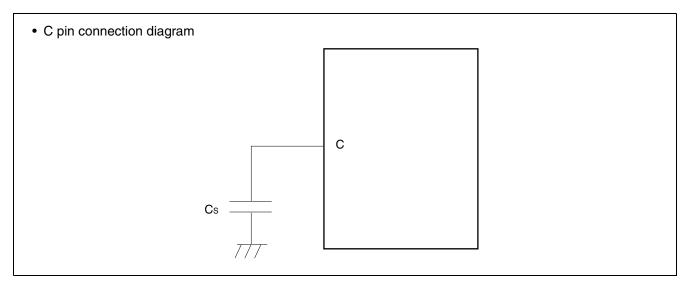
(Vss = 0.0 V)

Parameter	Symbol	mbol Conditions		Value		Bom	arke	
Farameter	Symbol	Conditions	Min	Max	Unit	Remarks		
			2.4*1,*2	5.5 <sup>*1</sup>		In normal operating	Other than	
Power supply	Vcc		2.3	5.5	V	Hold condition in STOP mode	MB95FV100D-103	
voltage	VCC		2.7	5.5		In normal operating	MB95FV100D-103	
			2.3	5.5		Hold condition in STOP mode		
Power supply voltage for LCD	V0 to V3		Vss	Vcc	v	The range of liquid crystal power supply (The optimal value depend on liquid crystal display elements used.)		
Smoothing capacitor	Cs		0.1	1.0	μF	*3		
Operating	TA		-40	+85	°C	Other than MB95FV1	00D-103	
temperature	IA		+5	+35	°C	MB95FV100D-103		

\*1 : The values vary with the operating frequency, machine clock or analog guarantee range.

\*2 : The value is 2.88 V when the low voltage detection reset is used.

\*3 : Use a ceramic capacitor or a capacitor with equivalent frequency characteristics. A bypass capacitor of V<sub>CC</sub> pin must have a capacitance value higher than C<sub>8</sub>. For connection of smoothing capacitor C<sub>8</sub>, refer to the diagram below.



WARNING: The recommended operating conditions are required in order to ensure the normal operation of the semiconductor device. All of the device's electrical characteristics are warranted when the device is operated within these ranges.

Always use semiconductor devices within their recommended operating condition ranges. Operation outside these ranges may adversely affect reliability and could result in device failure.

No warranty is made with respect to uses, operating conditions, or combinations not represented on the data sheet. Users considering application outside the listed conditions are advised to contact their FUJITSU representatives beforehand.

### 3. DC Characteristics

$(Vcc = 5.0 V \pm 10\%, Vss = 0.0 V, T_A = -40 \circ C to + 85 \circ C)$									
Parameter	Sym-	Pin name	Conditions		Value		Unit	Remarks	
Falameter	bol	Fill liame	Conditions	Min	Тур	Max	Unit	nemarks	
	VIH1	P10, P67	*1	0.7 Vcc		V <sub>cc</sub> + 0.3	V	When selecting CMOS input level	
	VIHA	P00 to P07, P10 to P14,		0.8 Vcc		Vcc + 0.3	V	Pin input at selecting of automotive input level	
"H" level input voltage	VIHS1	P60 to P67, P90 to P95, PA0 to PA3, PB0 to PB7	*1	0.8 Vcc	_	Vcc + 0.3	v	Hysteresis input	
	VIHM	RST, MOD		0.8 Vcc	_	Vcc + 0.3	V	Hysteresis input	
"L" level input	VIL	P10, P67	*1	V <sub>SS</sub> – 0.3		0.3 Vcc	V	When selecting CMOS input level (Hysteresis input)	
	VILA	P00 to P07, P10 to P14,	_	V <sub>ss</sub> – 0.3		0.5 Vcc	V	Pin input at selecting of automotive input level	
voltage	Vills P60 to P67, P90 to P95, PA0 to PA3, PB0 to PB7		*1	V <sub>SS</sub> – 0.3		0.2 Vcc	V	Hysteresis input	
	VILM	RST, MOD		V <sub>SS</sub> – 0.3		0.2 Vcc	V	Hysteresis input	
"H" level output voltage	Vон	All output pins	Іон = -4.0 mA	Vcc-0.5			V		
"L"level output voltage	Vol	All output pins, RST*2	lo∟ = 4.0 mA			0.4	V		
Input leak current (Hi-Z output leak current)	lu	Port other than P00 to P07, P10 to P14	0.0 V < Vı < Vcc	-5		+5	μA	When specifying without pull-up resistance	
Pull-up resistance	RPULL	P00 to P07, P10 to P14	$V_{I} = 0.0 \ V$	25	50	100	kΩ	When specifying with pull-up resistance	
Pull-down resistance	Rмор	MOD	$V_1 = V_{CC}$	50	100	200	kΩ	MASK ROM product only	

**\**\. -50V + 10% Vec -00V T<sub>4</sub> -40 °C to 1 95 °C)

Deverseter	Sym-	Din namo	Conditions		Value		11	Demerika				
Parameter	bol	Pin name	Conditions	Min	Тур	Max	Unit	Remarks				
				_	9.5	12.5	mA	Flash memory product (at other than Flash memory writing and erasing)				
						F <sub>CH</sub> = 20 MHz, F <sub>MP</sub> = 10 MHz	F <sub>MP</sub> = 10 MHz		30	35	mA	Flash memory product (at Flash memory writing and erasing)
			Main clock mode (divided by 2)		11.9	17.2	mA	Flash memory product (When A/D conversion)				
					7.2	9.5	mA	MASK ROM product				
	Icc				9.6	14.2	mA	MASK ROM product (When A/D conversion)				
	icc							_	15.2	20.0	mA	Flash memory product (at other than Flash memory writing and erasing)
			$V_{CC} = 5.5 V,$ $F_{CH} = 32 MHz,$ $F_{MP} = 16 MHz,$	—	35.7	42.5	mA	Flash memory product (at Flash memory writing and erasing)				
Power supply current*3			(External clock divided	(External clock divide	(External clock (divided by 2)	(External clock (divided by 2)	Main clock mode (divided by 2)		19.0	27.5	mA	Flash memory product (When A/D conversion)
									11.6	15.2	mA	MASK ROM product
					15.4	22.7	mA	MASK ROM product (When A/D conversion)				
	lccs		$\label{eq:Vcc} \begin{array}{l} V_{CC} = 5.5 \text{ V}, \\ F_{CH} = 20 \text{ MHz}, \\ F_{MP} = 10 \text{ MHz} \\ \text{Main sleep mode} \\ (\text{divided by 2}) \end{array}$		4.5	7.5	mA					
	ices		$\label{eq:Vcc} \begin{array}{l} V_{CC} = 5.5 \text{ V}, \\ F_{CH} = 32 \text{ MHz}, \\ F_{MP} = 16 \text{ MHz} \\ \text{Main sleep mode} \\ (\text{divided by 2}) \end{array}$	_	7.2	12.0	mA					
	Iccl		$\begin{split} V_{CC} &= 5.5 \text{ V}, \\ F_{CL} &= 32 \text{ kHz}, \\ F_{MPL} &= 16 \text{ kHz} \\ \text{Sub clock mode} \\ (\text{divided by 2}) \text{ ,} \\ T_{A} &= +25 \ ^{\circ}\text{C} \end{split}$		45	100	μΑ	(Continued)				

(Vcc = 5.0 V  $\pm$  10%, Vss = 0.0 V, T\_A = - 40 °C to + 85 °C)

Devementer	Sym-	Pin name	Conditions		Value		11	Domoriko
Parameter	bol	Pin name	Conditions	Min	Тур	Max	Unit	Remarks
	Iccls		$\label{eq:Vcc} \begin{array}{l} V_{CC} = 5.5 \ V, \\ F_{CL} = 32 \ kHz, \\ F_{MPL} = 16 \ kHz \\ Sub \ sleep \ mode \\ (divided \ by \ 2) \ , \\ T_A = \ + \ 25 \ ^{\circ}C \end{array}$	_	10	81	μΑ	
Power supply current*3	Ісст		$V_{CC} = 5.5 V,$ $F_{CL} = 32 \text{ kHz}$ Watch mode, Main stop mode $T_A = +25 \text{ °C}$		4.6	27.0	μΑ	
			Vcc = 5.5 V, Fcн = 4 MHz, FмP = 10 MHz		9.3	12.5	mA	Flash memory product
	ICCMPLL	ICTS	Main PLL mode (multiplied by 2.5)	_	7.0	9.5	mA	MASK ROM product
			Vcc = 5.5 V, Fcн = 6.4 MHz, FмP = 16 MHz		14.9	20.0	mA	Flash memory product
			Main PLL mode (multiplied by 2.5)		11.2	15.2	mA	MASK ROM product
	ICCSPLL		$V_{CC} = 5.5 V,$ $F_{CL} = 32 \text{ kHz},$ $F_{MPL} = 128 \text{ kHz}$ Sub PLL mode (multiplied by 4) $T_{A} = +25 \text{ °C}$		160	400	μA	
	Істѕ		$V_{CC} = 5.5 V,$ $F_{CH} = 10 MHz$ Time-base timer mode $T_A = +25 \ ^{\circ}C$		0.40	1.10	mA	
	Іссн		$V_{CC} = 5.5 V,$ Sub stop mode $T_{A} = +25 \text{ °C}$	_	3.5	20	μA	
LCD division resistance	RLCD		Between V3 and Vss		300		kΩ	
COM0 to COM3 output impedance	Rvсом	COM0 to COM3	V1 to V3 = 5.0V			5	kΩ	
SEG00 to SEG15 output impedance	Rvseg	SEG00 to SEG15	V 1 10 V3 = 5.0V	_		7	kΩ	

(Vcc = 5.0 V  $\pm$  10%, Vss = 0.0 V, T\_A = - 40 °C to + 85 °C)

(Continued)

 $(Vcc = 5.0 V \pm 10\%, Vss = 0.0 V, T_A = -40 \circ C to + 85 \circ C)$ 

Parameter	Sym- bol	Pin name	Conditions		Value	Unit	Remarks	
				Min	Тур	Max	Unit	nemarks
LCD leak current	ILCDL	V0 to V3 COM0 to COM3 SEG00 to SEG15		-1		+1	μA	
Input capacitance	CIN	Other than Vcc, Vss	f = 1 MHz		5	15	pF	

\*1: P10 and P67 can switch the input level to either the "CMOS input level" or "hysteresis input level". The switching of the input level can be set by the input level selection register (ILSR).

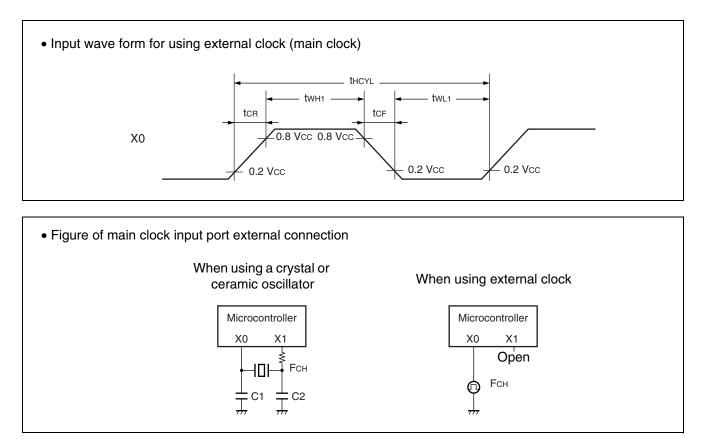
- \*2 : Product without clock supervisor only
- \*3: The power-supply current is determined by the external clock. When both low voltage detection option and clock supervisor are selected, the power-supply current will be a value of adding current consumption of the low voltage detection circuit (ILVD) and current consumption of built-in CR oscillator (ICSV) to the specified value.
  - Refer to "4. AC Characteristics (1) Clock Timing" for FCH and FCL.
  - Refer to "4. AC Characteristics (2) Source Clock/Machine Clock" for FMP and FMPL.

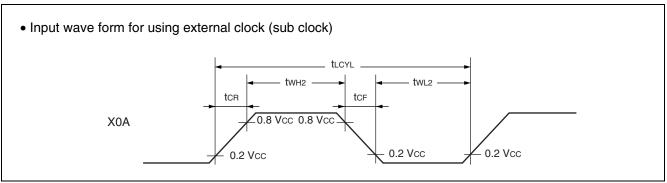
### 4. AC Characteristics

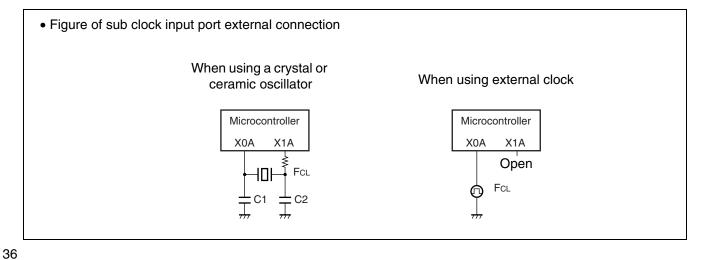
### (1) Clock Timing

	Sym- bol	Pin name	Condi- tions	Value				, ,
Parameter				Min	Тур	Мах	Unit	Remarks
Clock frequency	Fсн	X0, X1		1.00	_	16.25	MHz	When using main oscillation circuit
				1.00		32.50	MHz	When using external clock
				3.00		10.00	MHz	Main PLL multiplied by 1
				3.00		8.13	MHz	Main PLL multiplied by 2
				3.00		6.50	MHz	Main PLL multiplied by 2.5
				3.00		4.06	MHz	Main PLL multiplied by 4
	Fc∟	X0A, X1A			32.768		kHz	When using sub oscillation circuit
					32.768		kHz	When using sub PLL
Clock cycle time	<b>t</b> HCYL	X0, X1		61.5		1000	ns	When using oscillation circuit
				30.8	—	1000	ns	When using external clock
	<b>t</b> LCYL	X0A, X1A			30.5		μs	When using sub clock
Input clock pulse width	twнı tw∟ı	X0		61.5	_	_	ns	When using external clock
	tw⊦₂ tw∟₂	X0A		Duty ratio is about 30% to 70%.				
Input clock rise time and fall time	tcr tcr	X0, X0A				5	ns	When using external clock

#### (Vcc = 2.4 V to 5.5 V, Vss = 0.0 V, T\_A = $-40 \ ^\circ C$ to $+85 \ ^\circ C$ )





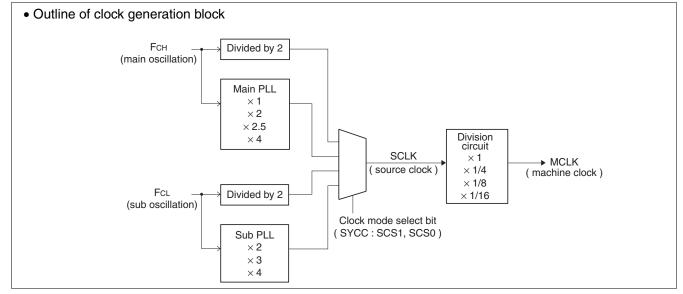


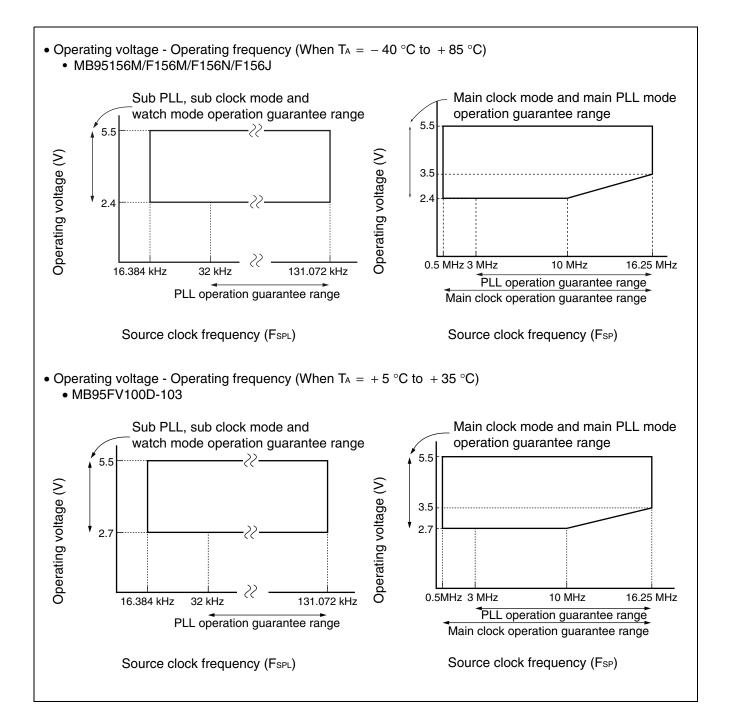
#### (2) Source Clock/Machine Clock

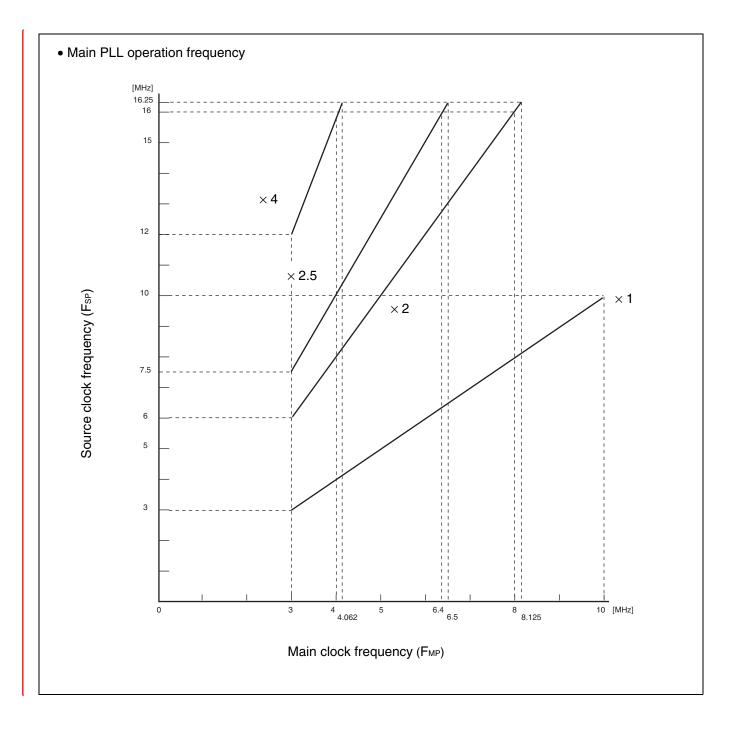
(2) 000100 01001	$(Vcc = 5.0 V \pm 10\%, Vss = 0.0 V, T_A = -40 \circ C to + 85 \circ C)$										
Parameter	Sym-	Pin	Condi-		Valu	е	Unit	Remarks			
rarameter	bol	name	tions	Min	Тур	Мах	Onic	nemarka			
Source clock cycle time*1	tsclk			61.5	_	2000	ns	When using main clock Min : $F_{CH} = 8.125$ MHz, PLL multiplied by 2 Max : $F_{CH} = 1$ MHz, divided by 2			
(Clock before setting division)	ISCLK	_		7.6		61.0	μs	When using sub clock Min : $F_{CL} = 32$ kHz, PLL multiplied by 4 Max : $F_{CL} = 32$ kHz, divided by 2			
Source clock	Fs₽			0.50		16.25	MHz	When using main clock			
frequency	FSPL			16.384		131.072	kHz	When using sub clock			
Machine clock cycle time* <sup>2</sup> (Minimum	tMCLK			61.5	_	32000	ns	When using main clock Min : $F_{SP} = 16.25$ MHz, no division Max : $F_{SP} = 0.5$ MHz, divided by 16			
instruction execution time)	INICLK			7.6		976.5	μs	When using sub clock Min :FsPL = 131 kHz, no division Max:FsPL = 16 kHz, divided by 16			
Machine clock	Fмp			0.031		16.250	MHz	When using main clock			
frequency	FMPL			1.024		131.072	kHz	When using sub clock			

\*1: Clock before setting division due to machine clock division ratio selection bit (SYCC : DIV1 and DIV0). This source clock is divided by the machine clock division ratio selection bit (SYCC : DIV1 and DIV0), and it becomes the machine clock. Further, the source clock can be selected as follows.

- Main clock divided by 2
- PLL multiplication of main clock (select from 1, 2, 2.5, 4 multiplication)
- Sub clock divided by 2
- PLL multiplication of sub clock (select from 2, 3, 4 multiplication)
- \*2: Operation clock of the microcontroller. Machine clock can be selected as follows.
  - Source clock (no division)
  - Source clock divided by 4
  - Source clock divided by 8
  - Source clock divided by 16





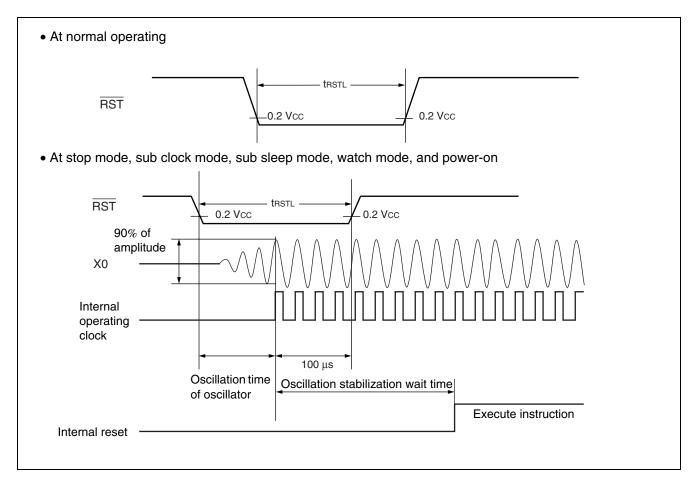


#### (3) External Reset

				$(Vcc = 5.0 V \pm 10\%, Vss =$	= 0.0 V, T	A = -	40 °C to + 85 °C)
Parameter	Symbol	Pin	Conditions	Value		Unit	Remarks
Farameter	Symbol	name	Conditions	Min	Max	Onit	nemarks
			2 tmclk*1	_	ns	At normal operating	
RST "L" level pulse width	<b>t</b> rstl	RST		Oscillation time of oscillator*2 + 100		μs	At stop mode, sub clock mode, sub sleep mode, and watch mode
				100		μs	At time-base timer mode

\*1 : Refer to " (2) Source Clock/Machine Clock" for tmclk.

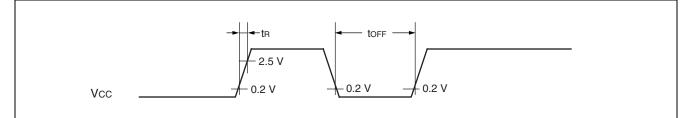
\*2 : Oscillation time of oscillator is the time that the amplitude reaches 90 %. In the crystal oscillator, the oscillation time is between several ms and tens of ms. In ceramic oscillators, the oscillation time is between hundreds of μs and several ms. In the external clock, the oscillation time is 0 ms.



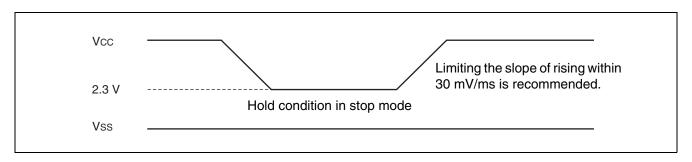
#### (4) Power-on Reset

 $(Vss = 0.0 V, T_A = -40 \circ C to + 85 \circ C)$ 

Parameter	Symbol	Pin	Conditions	Va	ue	Unit	Remarks	
Falameter	Symbol	name	Conditions	Min	Мах	Unit		
Power supply rising time	tR	Vcc			50	ms		
Power supply cutoff time	toff	VCC		1	_	ms	Waiting time until power-on	



Note : Sudden change of power supply voltage may activate the power-on reset function. When changing power supply voltages during operation, set the slope of rising within 30 mV/ms as shown below.

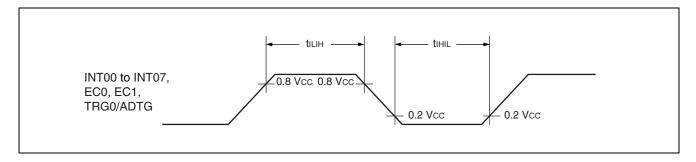


### (5) Peripheral Input Timing

 $(Vcc = 5.0 V \pm 10\%, Vss = 0.0 V, T_A = -40 \circ C to + 85 \circ C)$ 

Parameter	Symbol	Pin name	Conditions	Va	Unit	
Falanietei	Symbol	Fiirnaine	Conditions	Min	Max	Unit
Peripheral input "H" pulse width	tiliн	INT00 to INT07,		2 <b>t</b> мськ*		ns
Peripheral input "L" pulse width	tını∟	EC0, EC1, TRG0/ADTG		<b>2 t</b> мськ*		ns

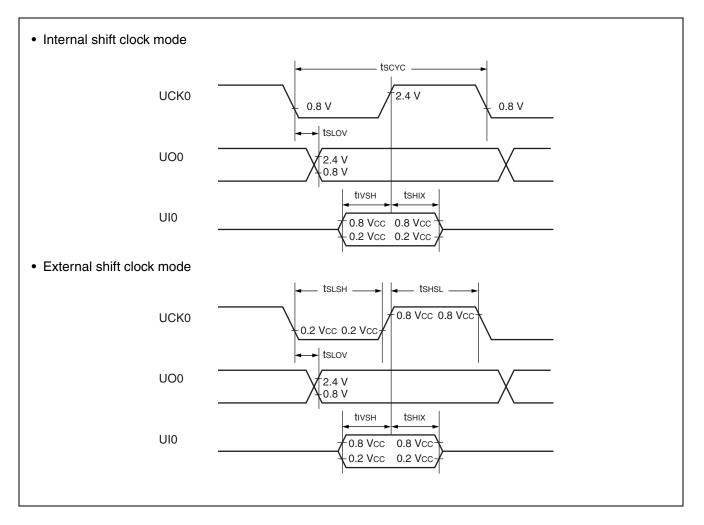
\*: Refer to " (2) Source Clock/Machine Clock" for tMCLK.



#### (6) UART/SIO, Serial I/O Timing

(-,		(V	$cc = 5.0 \text{ V} \pm 10\%$ , $Vss =$	0.0 V, T <sub>A</sub> =	– 40 °C to	+ 85 °C)	
Parameter	Symbol	Pin name	Conditions	Va	Unit		
Falameter	Symbol		conditions	Min	Max		
Serial clock cycle time	<b>t</b> scyc	UCK0	Internal	<b>4 t</b> мськ*		ns	
UCK $\downarrow \rightarrow$ UO time	tslov	UCK0, UO0	clock operation	- 190	+ 190	ns	
Valid UI $\rightarrow$ UCK $\uparrow$	tıvsн	UCK0, UI0	Output pin : CL = 80 pF	<b>2 t</b> мськ*		ns	
UCK $\uparrow \rightarrow$ valid UI hold time	tsнix	UCK0, UI0	+ 1TTL.	<b>2 t</b> мськ*		ns	
Serial clock "H" pulse width	tshsl	UCK0	Esternel.	<b>4 t</b> мськ*		ns	
Serial clock "L" pulse width	tslsh	UCK0	External clock	<b>4 t</b> мськ*		ns	
$UCK \downarrow \rightarrow UO$ time	tslov	UCK0, UO0	operation		190	ns	
Valid UI $\rightarrow$ UCK $\uparrow$	tıvsн	UCK0, UI0	Output pin : C∟ = 80 pF + 1TTL.	<b>2 t</b> мськ*		ns	
$UCK \uparrow \rightarrow valid UI hold time$	tsнix	UCK0, UI0		<b>2 t</b> мськ*		ns	

\* : Refer to " (2) Source Clock/Machine Clock" for tmclk.



#### (7) LIN-UART Timing

# Sampling at the rising edge of sampling clock<sup>\*1</sup> and prohibited serial clock delay<sup>\*2</sup> (ESCR register : SCES bit = 0, ECCR register : SCDE bit = 0)

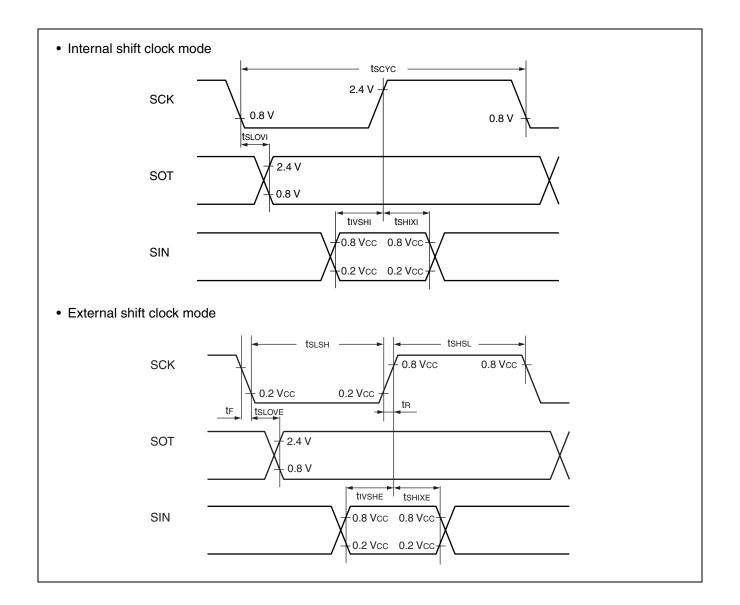
 $(Vcc = 5.0 V \pm 10\%, Vss = 0.0 V, T_A = -40 \circ C to + 85 \circ C)$ 

	1	i	$(VCC = 5.0 V \pm 10\%)$	·		
Parameter	Sym-	Pin name	Conditions	Va	Unit	
raiameter	bol	r in name	Conditions	Min	Мах	Onit
Serial clock cycle time	tscyc	SCK		5 <b>t</b> мськ* <sup>3</sup>	—	ns
$SCK \downarrow \to SOT$ delay time	tslovi	SCK, SOT	Internal clock	-95	+ 95	ns
$Valid\ SIN \to SCK\ \uparrow$	tivshi	SCK, SIN	operation output pin : $C_{L} = 80 \text{ pF} + 1 \text{ TTL}.$	tмськ*3 + 190		ns
SCK $\uparrow \rightarrow$ valid SIN hold time	tshixi	SCK, SIN		0		ns
Serial clock "L" pulse width	tslsh	SCK		$3 t_{\text{MCLK}^{*3}} - t_{\text{R}}$	—	ns
Serial clock "H" pulse width	tshsl	SCK		<b>t</b> мськ*3 + 95		ns
$SCK \downarrow \to SOT$ delay time	<b>t</b> SLOVE	SCK, SOT	External clock		2 tмськ*3 + 95	ns
$Valid\ SIN \to SCK\ \uparrow$	tivshe	SCK, SIN	operation output pin :	190	—	ns
SCK $\uparrow \rightarrow$ valid SIN hold time	tshixe	SCK, SIN	C∟ = 80 pF + 1 TTL.	<b>t</b> мськ*3 + 95	—	ns
SCK fall time	t⊧	SCK			10	ns
SCK rise time	tR	SCK			10	ns

\*1 : Provide switch function whether sampling of reception data is performed at rising edge or falling edge of the serial clock.

\*2 : Serial clock delay function is used to delay half clock for the output signal of serial clock.

\*3: Refer to " (2) Source Clock/Machine Clock" for tmclk.



# Sampling at the falling edge of sampling $clock^{*1}$ and prohibited serial $clock delay^{*2}$ (ESCR register : SCES bit = 1, ECCR register : SCDE bit = 0)

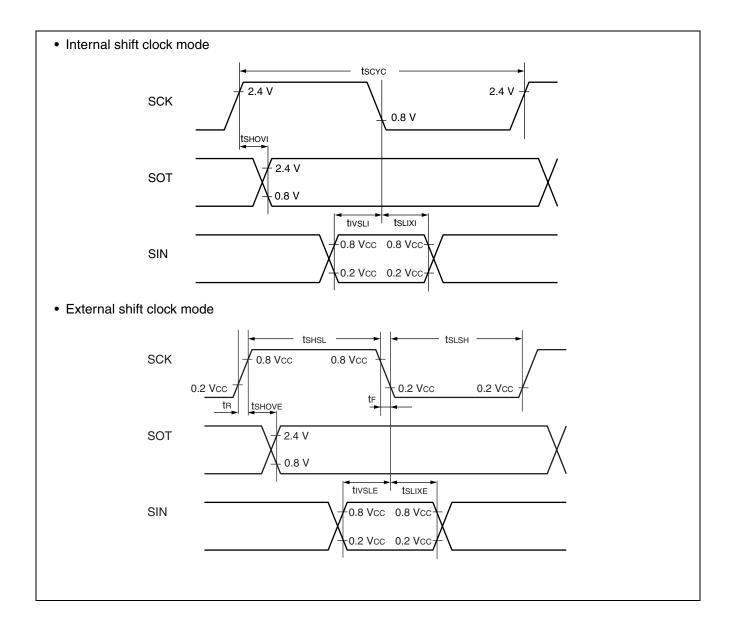
 $(V_{CC} = 5.0 \text{ V} \pm 10\%, \text{ Vss} = 0.0 \text{ V}, \text{ T}_{A} = -40 \text{ }^{\circ}\text{C} \text{ to } + 85 \text{ }^{\circ}\text{C})$ 

Parameter	Sym-	Pin name	Conditions	Va	lue	Unit
Falameter	bol		Conditions	Min	Max	Unit
Serial clock cycle time	tscyc	SCK		5 <b>t</b> MCLK <sup>*3</sup>		ns
$SCK^{\uparrow} \rightarrow SOT$ delay time	tshovi	SCK, SOT	Internal clock operation output pin :	-95	+ 95	ns
Valid SIN $ ightarrow$ SCK $\downarrow$	tivsli	SCK, SIN	$C_{L} = 80 \text{ pF} + 1 \text{ TTL}.$	tмськ* <sup>3</sup> + 190		ns
$SCK \downarrow \rightarrow valid \ SIN \ hold \ time$	tslixi	SCK, SIN		0		ns
Serial clock "H" pulse width	tsнs∟	SCK		3 tmclk <sup>*3</sup> – tr		ns
Serial clock "L" pulse width	<b>t</b> s∟sн	SCK		<b>t</b> мськ* <sup>3</sup> + 95		ns
$SCK^{\uparrow} \rightarrow SOT$ delay time	<b>t</b> shove	SCK, SOT	External clock		2 <b>t</b> мськ*3 + 95	ns
Valid SIN $ ightarrow$ SCK $\downarrow$	tivsle	SCK, SIN	operation output pin :	190		ns
$SCK \downarrow \rightarrow valid \ SIN \ hold \ time$	tslixe	SCK, SIN	C∟ = 80 pF + 1 TTL.	<b>t</b> мськ* <sup>3</sup> + 95		ns
SCK fall time	t⊧	SCK			10	ns
SCK rise time	t₽	SCK		_	10	ns

\*1 : Provide switch function whether sampling of reception data is performed at rising edge or falling edge of the serial clock.

\*2 : Serial clock delay function is used to delay half clock for the output signal of serial clock.

\*3: Refer to " (2) Source Clock/Machine Clock" for tMCLK.

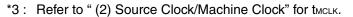


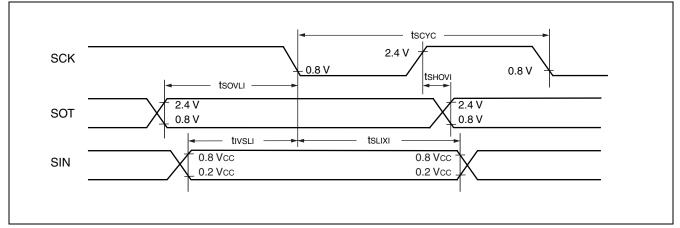
# Sampling at the rising edge of sampling $clock^{*1}$ and enabled serial $clock delay^{*2}$ (ESCR register : SCES bit = 0, ECCR register : SCDE bit = 1)

		•	$(V_{CC} = 5.0 \text{ V} \pm 10\%)$	, Vss = 0.0 V, T	$a = -40 ^{\circ}\text{C}$ to	+ 85 °C
Parameter	Sym-	Pin name	Conditions	Valu	Unit	
	bol		Conditions	Min	Max	Unit
Serial clock cycle time	<b>t</b> scyc	SCK		5 <b>t</b> MCLK <sup>*3</sup>		ns
$SCK^{\uparrow} \to SOT$ delay time	<b>t</b> shovi	SCK, SOT	Internal clock	-95	+ 95	ns
Valid SIN→SCK↓	tivsli	SCK, SIN	operation output pin :	tмськ*3 + 190		ns
$\text{SCK}{\downarrow}{\rightarrow}$ valid SIN hold time	tslixi	SCK, SIN	C∟ = 80 pF + 1 TTL.	0		ns
SOT $\rightarrow$ SCK $\downarrow$ delay time	tsov⊔	SCK, SOT			4 <b>t</b> мськ* <sup>3</sup>	ns

\*1 : Provide switch function whether sampling of reception data is performed at rising edge or falling edge of the serial clock.

\*2 : Serial clock delay function is used to delay half clock for the output signal of serial clock.





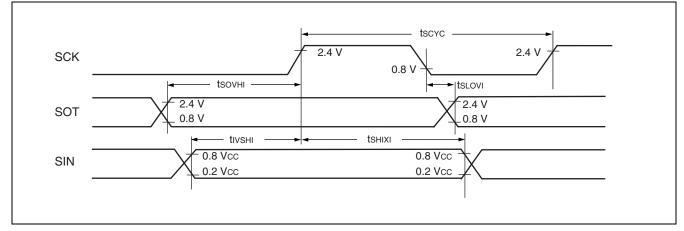
# Sampling at the falling edge of sampling $clock^{*1}$ and enabled serial $clock delay^{*2}$ (ESCR register : SCES bit = 1, ECCR register : SCDE bit = 1)

	-	U	$(Vcc = 5.0 V \pm 10\%)$	$V_{ss} = 0.0 V, T$	$\dot{A} = -40 \ ^{\circ}C$ to	+ 85 °C)
Parameter	Sym-	Pin name	Conditions	Valu	Unit	
Parameter	bol		Conditions	Min	Max	Onit
Serial clock cycle time	tscyc	SCK		<b>5 t</b> мськ* <sup>3</sup>		ns
SCK↓→SOT delay time	tslovi	SCK, SOT	Internal clock	-95	+ 95	ns
Valid SIN→SCK↑	tivshi	SCK, SIN	operation output pin :	tмськ*з + 190	_	ns
$SCK^{\uparrow} \to valid \ SIN \ hold \ time$	tshixi	SCK, SIN	$C_{L} = 80 \text{ pF} + 1 \text{ TTL}.$	0		ns
SOT→SCK <sup>↑</sup> delay time	tsovнı	SCK, SOT		_	4 t <sub>MCLK</sub> *3	ns

\*1 : Provide switch function whether sampling of reception data is performed at rising edge or falling edge of the serial clock.

\*2 : Serial clock delay function is used to delay half clock for the output signal of serial clock.

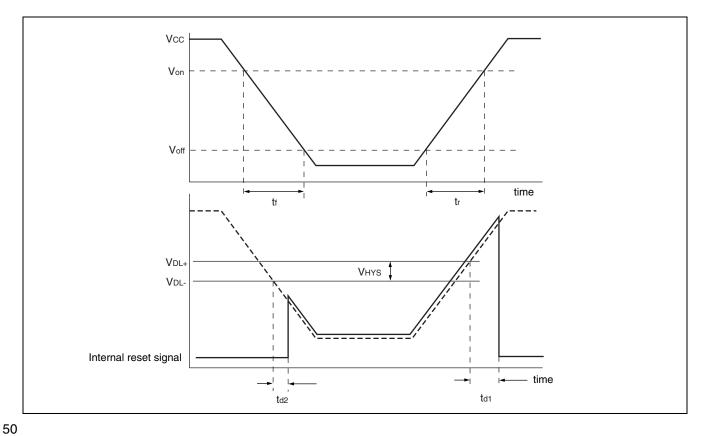
\*3: Refer to " (2) Source Clock/Machine Clock" for tmclk.



### (8) Low Voltage Detection

 $(Vss = 0.0 V, T_A = -40 \circ C to + 85 \circ C)$ 

Parameter	Symbol	Condi-		Value		Unit	Remarks
Falameter	Symbol	tions	Min	Тур	Max	Unit	nelliaiks
Release voltage	V <sub>DL+</sub>		2.52	2.70	2.88	V	At power-supply rise
Detection voltage	Vdl-		2.42	2.60	2.78	V	At power-supply fall
Hysteresis width	VHYS		70	100		mV	
Power-supply start voltage	Voff				2.3	V	
Power-supply end voltage	Von		4.9			V	
Power-supply voltage			0.3	_		μs	Slope of power supply that reset release signal generates
change time (at power supply rise)	tr		_	3000	_	μs	Slope of power supply that reset release signal generates within rating (V <sub>DL+</sub> )
Power-supply voltage			300	_		μs	Slope of power supply that reset detection signal generates
change time (at power supply fall)	tr			300	_	μs	Slope of power supply that reset detection signal generates within rating (V <sub>DL</sub> -)
Reset release delay time	t <sub>d1</sub>			_	400	μs	
Reset detection delay time	t <sub>d2</sub>			—	30	μs	
Current consumption	LVD			38	50	μA	Current consumption of low voltage detection circuit only



### (9) Clock Supervisor Clock

$(Vcc = 5.0 V \pm 10\%)$	$Vss = 0.0 V, T_A = -40$	) °C to + 85 °C)
--------------------------	--------------------------	------------------

Parameter	Symbol	Symbol	Symbol	Condi-		Value		Unit	Remarks
Falameter	Symbol	tions	Min	Тур	Мах	Onit	nemarks		
Oscillation frequency	fouт		50	100	200	kHz			
Oscillation start time	t <sub>wk</sub>				10	μs			
Current consumption	lcsv			20	36	μA	Current consumption of built-in CR oscillator, at 100 kHz oscillation		

### 5. A/D Converter

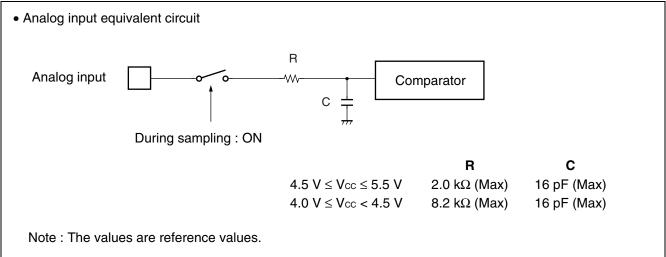
### (1) A/D Converter Electrical Characteristics

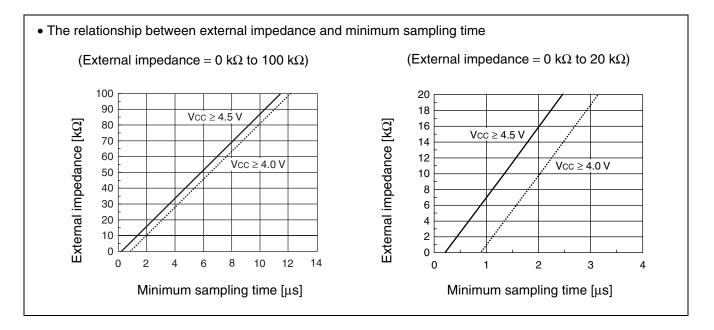
$(Vcc = 4.0 V \text{ to } 5.5 V, Vss = 0.0 V, T_A = -40 \text{ °C to } + 85 \text{ °C}$						$T_{A} = -40 \ ^{\circ}C \ to \ +85 \ ^{\circ}C)$
Parameter	Symbol	Value			Unit	Remarks
Farameter	Symbol	Min	Min Typ		Onit	neillaiks
Resolution		—		10	bit	
Total error		- 3.0		+ 3.0	LSB	
Linearity error		- 2.5		+ 2.5	LSB	
Differential linear error		- 1.9		+ 1.9	LSB	
Zero transition voltage	Vот	Vss – 1.5 LSB	Vss + 0.5 LSB	Vss + 2.5 LSB	V	
Full-scale transition voltage	VFST	Vcc – 3.5 LSB	Vcc – 1.5 LSB	Vcc + 0.5 LSB	V	
Compore time		0.9		16500	μs	$4.5~V \le V_{CC} \le 5.5~V$
Compare time		1.8		- 16500 μs 4.0 V ≤ V		$4.0 \text{ V} \leq \text{V}_{\text{CC}} < 4.5 \text{ V}$
0.6		0.6		∞	μs	$\begin{array}{l} 4.5 \ V \leq V_{CC} \leq 5.5 \ V, \\ \text{At external impedance} < \\ 5.4 \ k\Omega \end{array}$
Sampling time		1.2		œ	μs	$\begin{array}{l} 4.0 \ V \leq V_{CC} < 4.5 \ V, \\ \text{At external impedance} < \\ 2.4 \ k\Omega \end{array}$
Analog input current	Iain	-0.3	_	+ 0.3	μA	
Analog input voltage	VAIN	Vss	_	Vcc	V	

#### (2) Notes on Using A/D Converter

#### About the external impedance of analog input and its sampling time

A/D converter with sample and hold circuit. If the external impedance is too high to keep sufficient sampling time, the analog voltage charged to the internal sample and hold capacitor is insufficient, adversely affecting A/D conversion precision. Therefore, to satisfy the A/D conversion precision standard, consider the relationship between the external impedance and minimum sampling time and either adjust the register value and operating frequency or decrease the external impedance so that the sampling time is longer than the minimum value. Also, if the sampling time cannot be sufficient, connect a capacitor of about 0.1  $\mu$ F to the analog input pin.





#### About errors

As  $|V_{\text{CC}} - V_{\text{SS}}|$  becomes smaller, values of relative errors grow larger.

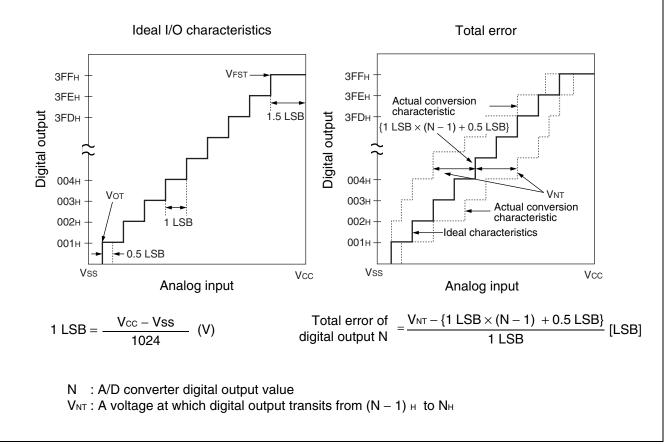
#### (3) Definition of A/D Converter Terms

Resolution
 The level of analog variation that can be distinguished by the A/D converter.
 When the number of bits is 10, analog voltage can be divided into 2<sup>10</sup> = 1024.

- Linearity error (unit : LSB)
   The deviation between the value along a straight line connecting the zero transition point
   ("00 0000 0000" ← → "00 0000 0001") of a device and the full-scale transition point
   ("11 1111 1111" ← → "11 1111 1110") compared with the actual conversion values obtained.
- Differential linear error (Unit : LSB) Deviation of input voltage, which is required for changing output code by 1 LSB, from an ideal value.

#### • Total error (unit: LSB)

Difference between actual and theoretical values, caused by a zero transition error, full-scale transition error, linearity error, quantum error, and noise.



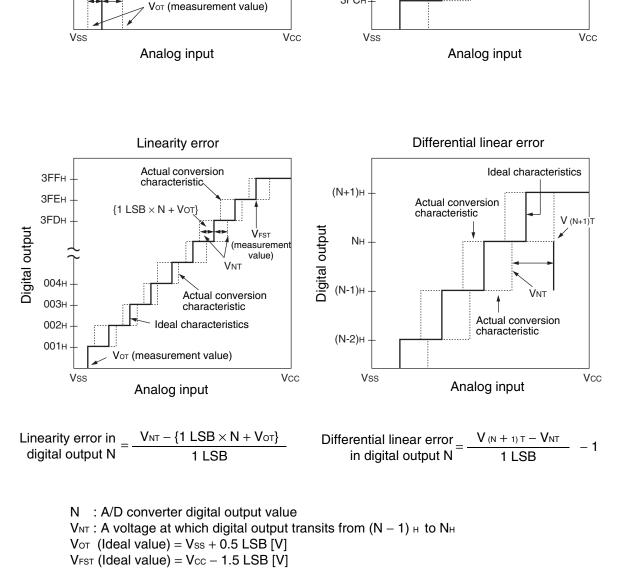
(Continued)

VFST

value)

#### Zero transition error Full-scale transition error 004н-Ideal characteristics Actual conversion 3FFH characteristic Actual conversion characteristic Digital output Digital output 003н-3FEн Ideal characteristics 002н Actual conversion (measurement 3FDH characteristic 001н Actual conversion characteristic 3FCH-

(Continued)



Parameter	Value			Unit	Remarks	
Faiailletei	Min	in Typ Max		Unit	nemarks	
Chip erase time	_	<b>1</b> .0*1	15.0* <sup>2</sup>	S	Excludes 00H programming prior erasure.	
Byte programming time		32	3600	μs	Excludes system-level overhead.	
Erase/program cycle	10000	_	_	cycle		
Power supply voltage at erase/ program	4.5		5.5	V		
Flash memory data retention time	<b>20</b> * <sup>3</sup>			year	Average T <sub>A</sub> = +85 °C	

### 6. Flash Memory Program/Erase Characteristics

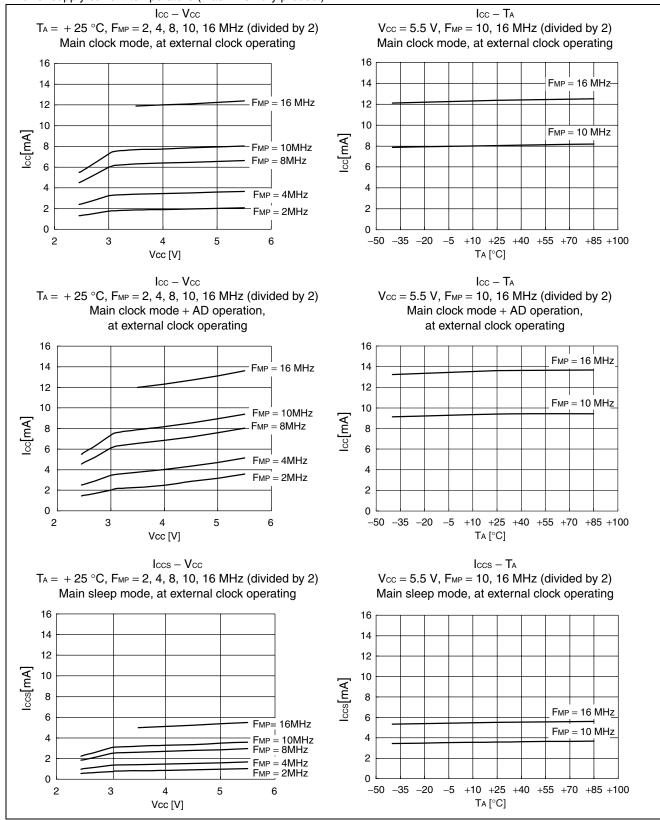
\*1 :  $T_A = +25 \ ^{\circ}C$ , Vcc = 5.0 V, 10000 cycles

\*2 :  $T_{\text{A}}=$  + 85 °C, Vcc = 4.5 V, 10000 cycles

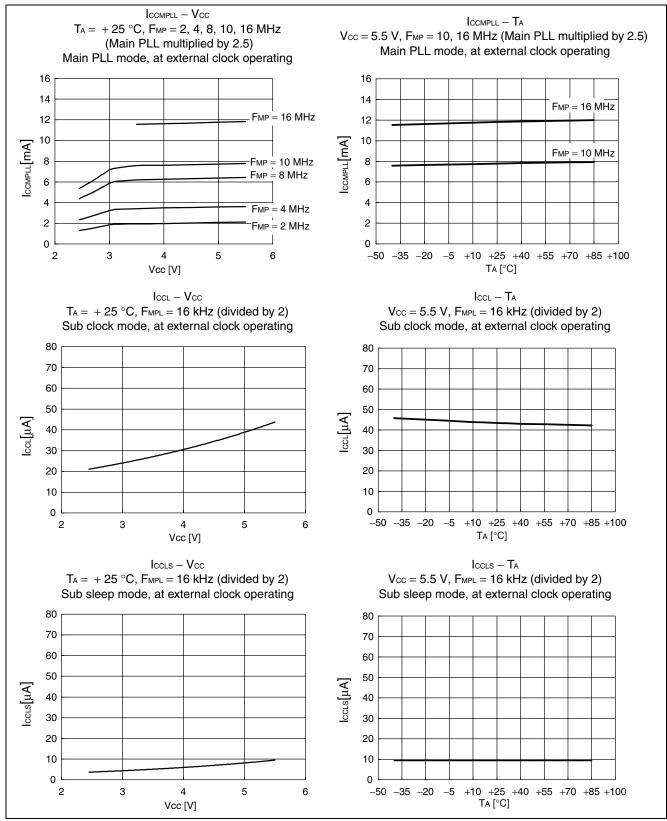
\*3 : This value comes from the technology qualification (using Arrhenius equation to translate high temperature measurements into normalized value at +85  $^{\circ}$ C).

### EXAMPLE CHARACTERISTICS

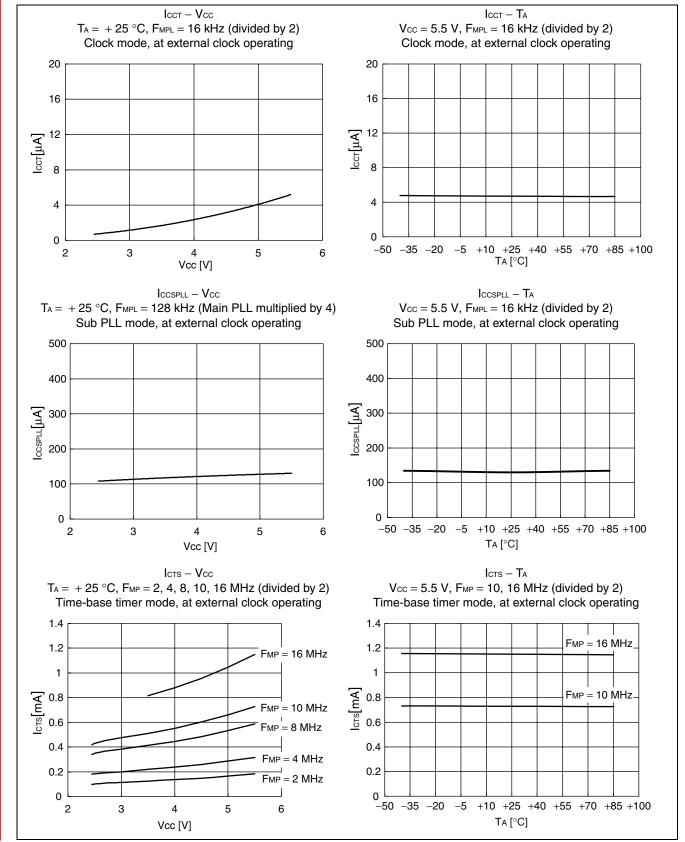
• Power supply current temperature (Flash memory product)



(Continued)

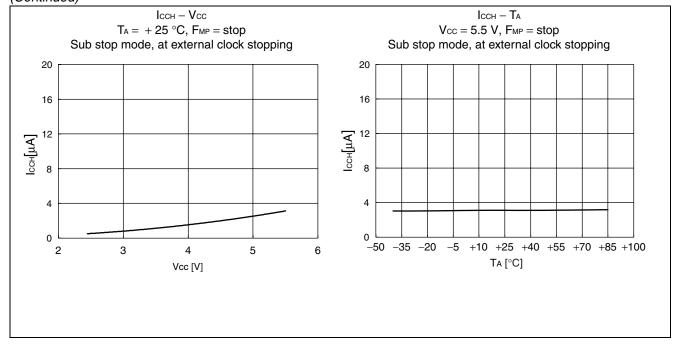


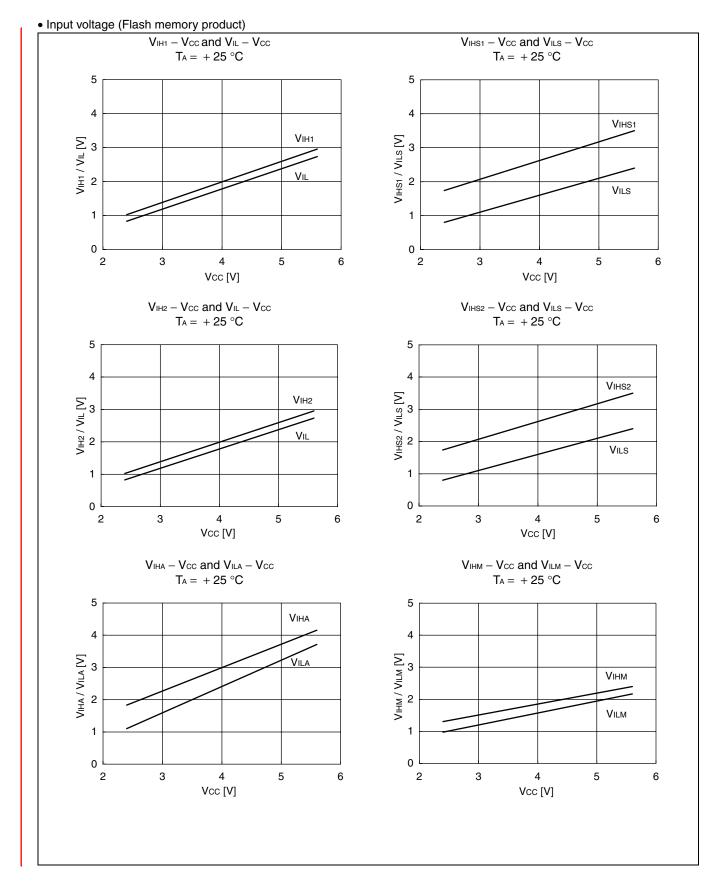
<sup>(</sup>Continued)

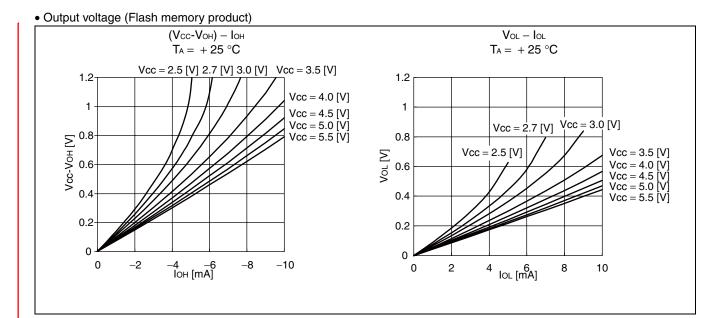


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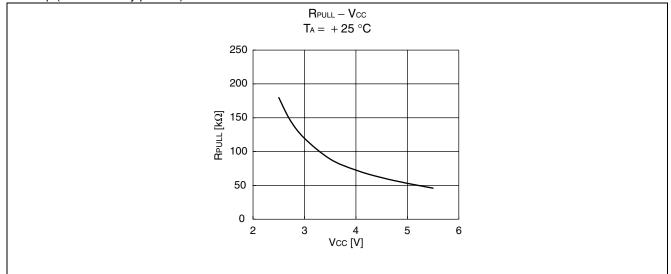
(Continued)







#### • Pull-up (Flash memory product)



### ■ MASK OPTION

No.	Part number	MB95156M	MB95F156M MB95F156N MB95F156J	MB95FV100D-103
	Specifying procedure	Specify when ordering MASK	Setting disabled	Setting disabled
1	Clock mode select • Single-system clock mode • Dual-system clock mode	Dual-system clock mode	Dual-system clock mode	Changing by the switch on MCU board
2	<ul> <li>Low voltage detection reset*</li> <li>With low voltage detection reset</li> <li>Without low voltage detection reset</li> </ul>	Specify when ordering MASK	Specified by part number	Changing by the switch on MCU board
3	Clock supervisor* • With clock supervisor • Without clock supervisor	Specify when ordering MASK	Specified by part number	Changing by the switch on MCU board
4	Reset output* • With reset output • Without reset output	Specify when ordering MASK	Specified by part number	<ul> <li>MCU board switch sets as follows ;</li> <li>With clock supervisor : Without reset output</li> <li>Without clock supervisor : With reset output</li> </ul>
5	Oscillation stabilization wait time	Fixed to oscillation stabilization wait time of $(2^{14} - 2)$ /F <sub>CH</sub>	Fixed to oscillation stabilization wait time of (2 <sup>14</sup> –2) /F <sub>CH</sub>	Fixed to oscillation stabiliza- tion wait time of (2 <sup>14</sup> –2) /F <sub>CH</sub>

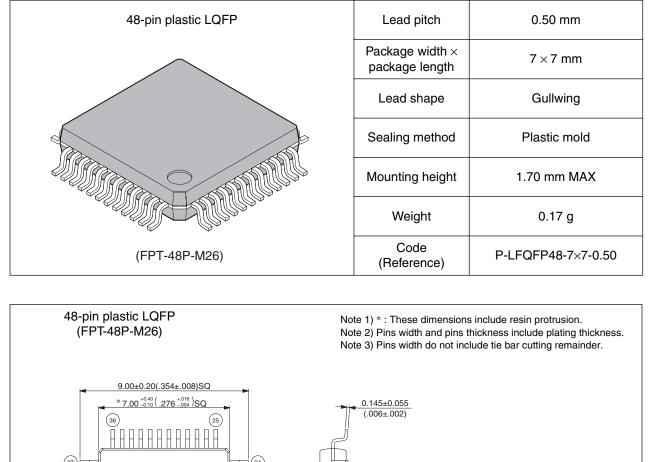
\*: Refer to table below about clock mode select, low voltage detection reset, clock supervisor select and reset output.

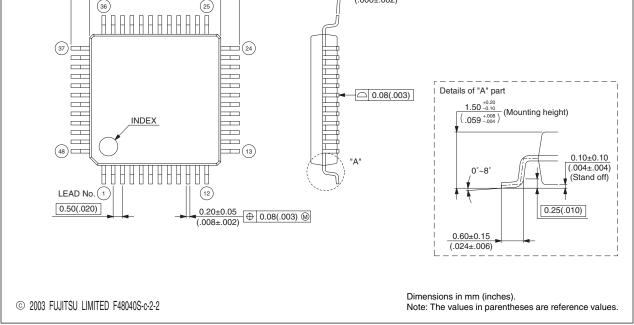
Part number	Clock mode select	Low voltage detection reset	Clock supervisor	Reset output
		No	No	Yes
MB95156M	Dual-system	Yes	No	Yes
		Yes	Yes	No
MB95F156M		No	No	Yes
MB95F156N	Dual-system	Yes	No	Yes
MB95F156J		Yes	Yes	No
MB95FV100D-103	Single-system	No	No	Yes
		Yes	No	Yes
		Yes	Yes	No
	Dual-system	No	No	Yes
		Yes	No	Yes
		Yes	Yes	No

### ■ ORDERING INFORMATION

Part number	Package
MB95156MPMT MB95F156MPMT MB95F156NPMT MB95F156JPMT	48-pin plastic LQFP (FPT-48P-M26)
MB95156MPMC MB95F156MPMC MB95F156NPMC MB95F156JPMC	52-pin plastic LQFP (FPT-52P-M01)
MB2146-303A (MB95FV100D-103PBT)	MCU board (224-pin plastic PFBGA (BGA-224P-M08)

#### PACKAGE DIMENSIONS

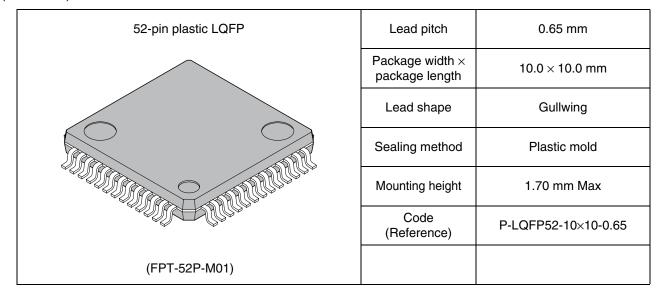


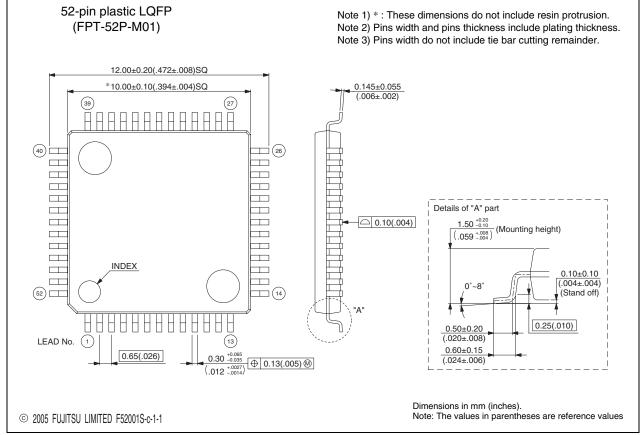


Please confirm the latest Package dimension by following URL. http://edevice.fujitsu.com/fj/DATASHEET/ef-ovpklv.html

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Please confirm the latest Package dimension by following URL. http://edevice.fujitsu.com/fj/DATASHEET/ef-ovpklv.html

Page	Section	Change Results
	_	Added the part numbers. MB95156M (MASK ROM Product)
15	<ul> <li>PROGRAMMING FLASH MEMORY MICROCONTROLLERS USING PARALLEL PROGRAMMER</li> <li>Programming Method</li> </ul>	Changed as follows "2) Load program data to programmer addresses $7800_{\text{H}}$ to $7\text{FFFF}_{\text{H}}$ ." $\rightarrow$ "2) Load program data to programmer addresses $18000_{\text{H}}$ to $1\text{FFFF}_{\text{H}}$ ."
21	■ I/O MAP Reset factor register	<ul> <li>Changed the register name to "Reset source register."</li> <li>Changed the item "R/W" as follows. "R" → "R/W"</li> </ul>
35	4. AC Characteristics (1) Clock Timing	Added the Main PLL multiplied by 4.
37	(2) Source Clock/Machine Clock	Changed source clock cycle time (when using main clock) . Min : $F_{CH} = 10$ MHz, PLL multiplied by 1 $\rightarrow$ Min : $F_{CH} = 8.125$ MHz, PLL multiplied by 2
39		Changed the figure of "   Main PLL operation frequency".
57 to 62	■ EXAMPLE CHARACTERISTICS	Added the ■ EXAMPLE CHARACTERISTICS.

The vertical lines marked in the left side of the page show the changes.

The information for microcontroller supports is shown in the following homepage. http://www.fujitsu.com/global/services/microelectronics/product/micom/support/index.html

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